Verification

Issue Date: May 26, 2022
Ref. Report No.: ISL-21LE654CE50155-R1-MA

Product Name : TEP 150UIR &TEP 200UIR Series
Model(s) : TEP 200-7213UIR-N;TEP 150-7211UIR-N; TEP 150-7212UIR-N; TEP 150-7213UIR-N; TEP 150-7215UIR-N; TEP 150-7216UIR-N; TEP 150-7218UIR-N; TEP 150-72153UIR-N; TEP 200-7211UIR-N; TEP 200-7212UIR-N; TEP 200-7215UIR-N; TEP 200-7216UIR-N; TEP 200-7218UIR-N; TEP 200-72153UIR-N; TEP 150-7211UIR-AN; TEP 150-7212UIR-AN; TEP 150-7213UIR-AN; TEP 150-7215UIR-AN; TEP 150-7216UIR-AN; TEP 150-7218UIR-AN; TEP 150-72153UIRAN; TEP 200-7211UIR-AN; TEP 200-7212UIR-AN; TEP 200-7213UIR-AN; TEP 200-7215UIR-AN; TEP 200-7216UIR-AN; TEP 200-7218UIR-AN; TEP 200-72153UIRAN; TEP 150-7211UIR; TEP 150-7212UIR; TEP 150-7213UIR; TEP 150-7215UIR; TEP 150-7216UIR; TEP 150-7218UIR; TEP 150-72153UIR; TEP 200-7211UIR; TEP 200-7212UIR; TEP 200-7213UIR; TEP 200-7215UIR; TEP 200-7216UIR; TEP 200-7218UIR; TEP 200-72153UIR; TEP 150-7211UIR-A; TEP 150-7212UIR-A; TEP 150-7213UIR-A; TEP 150-7215UIR-A; TEP 150-7216UIR-A; TEP 150-7218UIR-A; TEP 150-72153UIR-A; TEP 200-7211UIR-A; TEP 200-7212UIR-A; TEP 200-7213UIR-A; TEP 200-7215UIR-A; TEP 200-7216UIR-A; TEP 200-7218UIR-A; TEP 200-72153UIR-A
Applicant : TRACO ELECTRONIC AG
Address : Sihlbruggstrasse 111 CH-6340 Baar Switzerland
Brand : TRACO POWER

We, **International Standards Laboratory Corp.**, hereby certify that:

The sample ISL received which bearing the trade name and model specified above has been shown to comply with the applicable technical standards as indicated in the measurement report and was tested in accordance with the measurement procedures specified in European Council Directive EMC Directive 2014/30/EU and UK Directive Electromagnetic Compatibility Regulations 2016. And Our laboratories is the accredited laboratories and are approved according to ISO/IEC 17025. The device was passed the test performed according to :

Standards:

CE
EN 50155:2017 for EMC, Environmental and Characteristic
EN 50121-3-2:2016+A1:2019 for EMC
EN 60068-2-1:2007 for Environmental
EN 60068-2-2:2007 for Environmental
EN 60068-2-30:2005 for Environmental
EN 61373:2010 for Environmental

UK
BS EN 50155:2017
BS EN 50121-3-2:2016+A1:2019

I attest to the accuracy of data and all measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.
The determination of the test results is determined by customer agreement, regulations or standard document specifications.
The Laboratory evaluates measurement inaccuracies based on regulatory or standard document specifications and is listed in the report for reference. The quantitative project part judges the conformity of the test results based on the evaluation results of the standard cited uncertainty, and the qualitative project does not temporarily evaluate the measurement uncertainty.

Angus Chu

Angus Chu / Sr. Manager

International Standards Laboratory Corp. LT Lab.
TEL: +886-3-263-8888 FAX: +886-3-263-8899
No. 120, Lane 180, Hsin Ho Rd., Lung-Tan Dist., Tao Yuan City 325, Taiwan

ISL International Standards Laboratory Corp. http://www.isl.com.tw

TEST REPORT

of

EN 50155 / BS EN 50155
(EMC, Characteristic, Environmental Test)

Product : **TEP 150UIR &TEP 200UIR Series**
Model(s): **TEP 200-7213UIR-N**
(more serial models listed on Different Model list of this test report)

Brand: **TRACO POWER**
Applicant: **TRACO ELECTRONIC AG**
Address: **Sihlbruggstrasse 111 CH-6340 Baar Switzerland**

Test Performed by:

International Standards Laboratory Corp. LT Lab.
TEL: +886-3-263-8888 FAX: +886-3-263-8899
No. 120, Lane 180, Hsin Ho Rd., Lung-Tan Dist., Tao Yuan City 325, Taiwan

Report No.: **ISL-21LE654CE50155-R1-MA**
Issue Date : **May 26, 2022**

Test results given in this report apply only to the specific sample(s) tested and are traceable to national or international standard through calibration of the equipment and evaluating measurement uncertainty herein. The uncertainty of the measurement does not include in consideration of the test result unless the customer required the determination of uncertainty via the agreement, regulation or standard document specification.
This test report shall not be reproduced except in full, without the written approval of International Standards Laboratory Corp.

Contents of Report

1. General

1.1 Certification of Accuracy of Test Data

Standards:	Please refer to 1.2
Equipment Tested:	TEP 150UIR &TEP 200UIR Series
Model:	TEP 200-7213UIR-N (more serial models listed on Different Model list of this test report)
Brand:	TRACO POWER
Applicant:	TRACO ELECTRONIC AG
Sample received Date:	May 9, 2022
Final test Date:	EMI: refer to the date of test data EMS: June 29, 2021
Test Site:	Chamber 02; Conduction 03; Immunity 02
Test Distance:	10m (EMI test)
Temperature:	refer to each site test data
Humidity:	refer to each site test data
Input power:	Conduction input power: DC 72V; DC 110V Radiation input power: DC 72V; DC 110V Immunity input power: DC 72V
Test Result:	**PASS**
Report Engineer:	Cheryl Tung
Test Engineer:	Sawyer chiang Sawyer Chiang
Approved By:	Benson Chen Benson Chen / Manager

1.2 Test Standards

The tests which this report describes were conducted by an independent electromagnetic compatibility consultant, International Standards Laboratory Corp. in accordance with the following

☒EN 50155:2017 and BS EN 50155:2017 for EMC, Environmental and Characteristic
☒EN 50121-3-2:2016+A1:2019 and BS EN 50121-3-2:2016+A1:2019 for EMC
☒EN 60068-2-1:2007 for Environmental
☒EN 60068-2-2:2007 for Environmental
☒EN 60068-2-30:2005 for Environmental
☒EN 61373:2010 for Environmental

Characteristic Test					
Report Clause	Performed Item	EN 50155 Reference Clause(s)	Reference Standard	Result	Location of Test
2.1	Visual Inspection and Performance test	13.4.1 13.4.2	-	PASS	ISL LAB
2.2	Power Supply Test (Supply variations and Temporary supply dips)	13.4.3.2 13.4.3.3 5.1.1.2 5.1.1.3	-	PASS	ISL LAB
2.3	Power Supply Test (Interruptions of voltage supply)	13.4.3.4 5.1.1.4	-	PASS	ISL LAB
2.4	Power Supply Test (Supply charge-over)	13.4.3.5 5.1.3	-	PASS	ISL LAB
2.5	Insulation Test	13.4.9	-	PASS	ISL LAB
2.6	DC ripple factor	5.1.1.6	EN50155 EN61000-4-17	PASS	ISL LAB

Electromagnetic Compatibility (EMC)					
Report Clause	Performed Item	EN 50155 Reference Clause(s)	Reference Standard	Result	Location of Test
3.1	Power Line Conducted Emission Measurement	13.4.8	EN 50121-3-2 / BS EN 50121-3-2 EN 61000-6-4 / BS EN 61000-6-4	PASS	ISL LAB
3.2	Radiated Emission Measurement	13.4.8	EN 50121-3-2 / BS EN 50121-3-2 EN 61000-6-4 / BS EN 61000-6-4	PASS	ISL LAB
3.3	Electrostatic Discharge Susceptibility Test	13.4.8	EN 50121-3-2 / BS EN 50121-3-2 EN 61000-4-2 / BS EN 61000-4-2	PASS	ISL LAB
3.4	Radio- Frequency interference (RFI) susceptibility Test	13.4.8	EN 50121-3-2 / BS EN 50121-3-2 EN 61000-4-3 / BS EN 61000-4-3	PASS	ISL LAB
3.5	Transient Burst Susceptibility Test	13.4.8	EN 50121-3-2 / BS EN 50121-3-2 EN 61000-4-4 / BS EN 61000-4-4	PASS	ISL LAB
3.6	Surges Test	13.4.8	EN 50121-3-2 / BS EN 50121-3-2 EN 61000-4-5 / BS EN 61000-4-5	PASS	ISL LAB
3.7	Radio- Frequency, Conducted Disturbances Immunity Test	13.4.8	EN 50121-3-2 / BS EN 50121-3-2 EN 61000-4-6 / BS EN 61000-4-6	PASS	ISL LAB
3.8	Power Frequency Magnetic Field	13.4.8	EN 61000-4-8 / BS EN 61000-4-8	PASS	ISL LAB

Environmental Tests					
Report Clause	Performed Item	EN 50155 Reference Clause(s)	Reference Standard	Result	Location of Test
4.1	Low temperature star-up test	13.4.4	EN 60068-2-1	PASS	ISL LAB
4.2	Dry Heat Test	13.4.5	EN 60068-2-2	PASS	ISL LAB
4.3	Cyclic Damp Heat Test	13.4.7	EN 60068-2-30	PASS	ISL LAB
4.4	Random Vibration Test	13.4.11	EN 61373	PASS	GTTI LAB
4.5	Increased Random Vibration Test	13.4.11	EN 61373	PASS	GTTI LAB
4.6	Shock Test	13.4.11	EN 61373	PASS	GTTI LAB

GTTI LAB= GOLDEN-TECH TECHNOLOGIES INC.

1.2.1 Performance Criteria for Compliance

Performance criterion A:

The apparatus shall continue to operate as intended during and after the test/event. No degradation of performance or loss of function is allowed.
Changes of actual operating state or stored data are not allowed.
If agreed between the involved parties, the normal performance level (all functions are working as specified) can be replaced by a minimum performance level.

Performance criterion B:

The apparatus shall continue to operate as intended after the test/event.
During the test/event, degradation of performance is however allowed.
Changes of actual operating state or stored data are not allowed.

Performance criterion C:

During the test/event temporary loss of function is allowed. The equipment could:

- automatically restart. The normal performance shall be obtained within a maximum defined time.
  After this time the equipment shall retain the previous operating state and shall work as intended.
  The loss of significant data is not allowed; or
- manually restart or process controlled restart. In this case this shall be agreed between user and supplier and/or clearly defined in the user manual. In this case the user manual shall be available to the user at the tender stage.

NOTE Significant stored data are application dependent and stated into the Performance specifications.

1.2.2 Performance Criteria for Compliance: EN 50121-1 and BS EN 50121-1 (only for EMC)

Performance criterion A: The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.

Performance criterion B: The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed. No change of actual operating state or stored data are allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.

Performance criterion C: Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.

1.3 Description of EUT

EUT

This report test data using the report number ISL-21LE654CE50155-R1.

Description	TEP 150UIR &TEP 200UIR Series
Condition	Pre-Production
Model	TEP 200-7213UIR-N (more serial models listed on Different Model list of this test report)
Test Model	TEP 200-7213UIR-N
Brand	TRACO POWER
Serial Number	N/A
Highest working frequency	Less than 108MHz

Test EMI test configuration:

Configuration	Model Name	Input VDC	Output Voltage VDC
1	TEP 200-7213UIR-N	72	15
2		110	15

For EMS (Not Include Electrical Fast transients/burst immunity & Surge Immunity) test mode

Configuration	Model Name	Input VDC	Output Voltage VDC	With an aluminum electrolytic capacitor test board
1	TEP 200-7213UIR-N	72	15	No

For Electrical Fast transients/burst immunity & Surge Immunity test mode

Configuration	Model Name	Input VDC	Output Voltage VDC	With an aluminum electrolytic capacitor test board
1	TEP 200-7213UIR-N	72	15	Yes

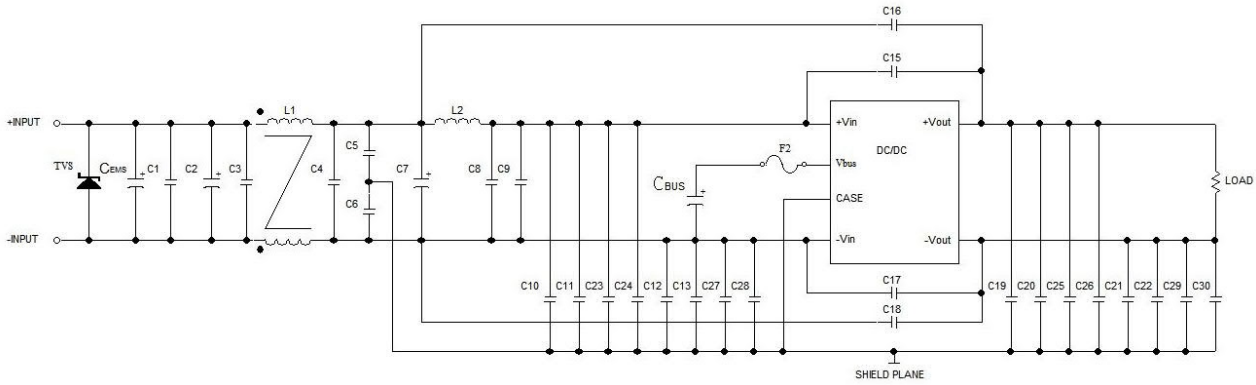
Different Model list:

Model Name	Input Range (VDC)	Output Voltage (VDC)
TEP 150-7211UIR-N	14 ~ 160	5
TEP 150-7212UIR-N	14 ~ 160	12
TEP 150-7213UIR-N	14 ~ 160	15
TEP 150-7215UIR-N	14 ~ 160	24
TEP 150-7216UIR-N	14 ~ 160	28
TEP 150-7218UIR-N	14 ~ 160	48
TEP 150-72153UIR-N	14 ~ 160	53
TEP 200-7211UIR-N	14 ~ 160	5
TEP 200-7212UIR-N	14 ~ 160	12
TEP 200-7213UIR-N	14 ~ 160	15
TEP 200-7215UIR-N	14 ~ 160	24
TEP 200-7216UIR-N	14 ~ 160	28
TEP 200-7218UIR-N	14 ~ 160	48
TEP 200-72153UIR-N	14 ~ 160	53
TEP 150-7211UIR-AN	14 ~ 160	5
TEP 150-7212UIR-AN	14 ~ 160	12
TEP 150-7213UIR-AN	14 ~ 160	15
TEP 150-7215UIR-AN	14 ~ 160	24
TEP 150-7216UIR-AN	14 ~ 160	28
TEP 150-7218UIR-AN	14 ~ 160	48
TEP 150-72153UIRAN	14 ~ 160	53
TEP 200-7211UIR-AN	14 ~ 160	5
TEP 200-7212UIR-AN	14 ~ 160	12
TEP 200-7213UIR-AN	14 ~ 160	15
TEP 200-7215UIR-AN	14 ~ 160	24
TEP 200-7216UIR-AN	14 ~ 160	28
TEP 200-7218UIR-AN	14 ~ 160	48
TEP 200-72153UIRAN	14 ~ 160	53
TEP 150-7211UIR	14 ~ 160	5
TEP 150-7212UIR	14 ~ 160	12
TEP 150-7213UIR	14 ~ 160	15
TEP 150-7215UIR	14 ~ 160	24
TEP 150-7216UIR	14 ~ 160	28
TEP 150-7218UIR	14 ~ 160	48
TEP 150-72153UIR	14 ~ 160	53
TEP 200-7211UIR	14 ~ 160	5
TEP 200-7212UIR	14 ~ 160	12
TEP 200-7213UIR	14 ~ 160	15
TEP 200-7215UIR	14 ~ 160	24
TEP 200-7216UIR	14 ~ 160	28
TEP 200-7218UIR	14 ~ 160	48
TEP 200-72153UIR	14 ~ 160	53

Model Name	Input Range (VDC)	Output Voltage (VDC)
TEP 150-7211UIR-A	14 ~ 160	5
TEP 150-7212UIR-A	14 ~ 160	12
TEP 150-7213UIR-A	14 ~ 160	15
TEP 150-7215UIR-A	14 ~ 160	24
TEP 150-7216UIR-A	14 ~ 160	28
TEP 150-7218UIR-A	14 ~ 160	48
TEP 150-72153UIR-A	14 ~ 160	53
TEP 200-7211UIR-A	14 ~ 160	5
TEP 200-7212UIR-A	14 ~ 160	12
TEP 200-7213UIR-A	14 ~ 160	15
TEP 200-7215UIR-A	14 ~ 160	24
TEP 200-7216UIR-A	14 ~ 160	28
TEP 200-7218UIR-A	14 ~ 160	48
TEP 200-72153UIR-A	14 ~ 160	53

EMI Noise Source:
Please refer to the technical documents.

Solution:
For EMI test requirements/Class B



TEP 200-7211UIR/TEP 200-7211UIR-A/TEP 200-7211UIR-N/TEP 200-7211UIR-AN

L1	L2	C2, C7	C1, C3	C19, C24	C21, C22, C23	C11, C13, C20, C27, C28	C25,C29	C15, C16, C18	C5	C6	TVS, CEMS, C4, C8, C9, C10, C12, C17, C26, C30,
415uH	3.3μH	150μF/ 200V	1μF/ 250V	1000pF/ 250Vac	680pF/ 250Vac	330pF/ 250Vac	100pF/ 250Vac	4700pF/ Y1	2200pF/ Y1	1000pF/ Y1	N/A

TEP 200-7212UIR/ TEP 200-7213UIR/ TEP 200-7215UIR/ TEP 200-7216UIR/
TEP 200-7212UIR-A/ TEP 200-7213UIR-A/ TEP 200-7215UIR-A/ TEP 200-7216UIR-A/
TEP 200-7212UIR-N/ TEP 200-7213UIR-N/ TEP 200-7215UIR-N/ TEP 200-7216UIR-N/
TEP 200-7212UIR-AN/ TEP 200-7213UIR-AN/ TEP 200-7215UIR-AN/ TEP 200-7216UIR-AN

L1	L2	C2, C7	C1, C3, C4	C19, C20, C21, C22, C23, C27	C11, C13	C24, C25, C28, C29	C15, C17	C5, C6, C16, C18	TVS, CEMS, C8, C9, C10, C12, C26, C30,
415uH	3.3μH	150μF/ 200V	1μF/ 250V	1000pF/ 250Vac	680pF/ 250Vac	100pF/ 250Vac	1000pF/ Y1	2200pF/ Y1	N/A

TEP 200-7218UIR/ TEP 200-72153UIR/ TEP 200-7218UIR-A/ TEP 200-72153UIR-A/
TEP 200-7218UIR-N/ TEP 200-72153UIR-N/ TEP 200-7218UIR-AN/ TEP 200-72153UIRAN

L1	L2	C2, C7	C1, C3, C9	C11, C13	C20, C22	C19, C21, C23, C24, C27, C28	C25, C29	C15, C17	C16, C18	TVS, CEMS, C4, C5, C6, C8, C10, C12, C26, C30,
415uH	3.3μH	150μF/ 200V	1μF/ 250V	680pF/ 250Vac	1000pF/ 250Vac	330pF/ 250Vac	100pF/ 250Vac	3300pF/ Y1	4700pF/ Y1	N/A

TEP 150-7211UIR/ TEP 150-7212UIR/ TEP 150-7213UIR/ TEP 150-7215UIR/
TEP 150-7216UIR/
TEP 150-7211UIR-A/ TEP 150-7212UIR-A/ TEP 150-7213UIR-A/ TEP 150-7215UIR-A/
TEP 150-7216UIR-A/ TEP 150-7211UIR-N/ TEP 150-7212UIR-N/ TEP 150-7213UIR-N/
TEP 150-7215UIR-N/ TEP 150-7216UIR-N/ TEP 150-7211UIR-AN/ TEP 150-7212UIR-AN/
TEP 150-7213UIR-AN/ TEP 150-7215UIR-AN/
TEP 150-7216UIR-AN

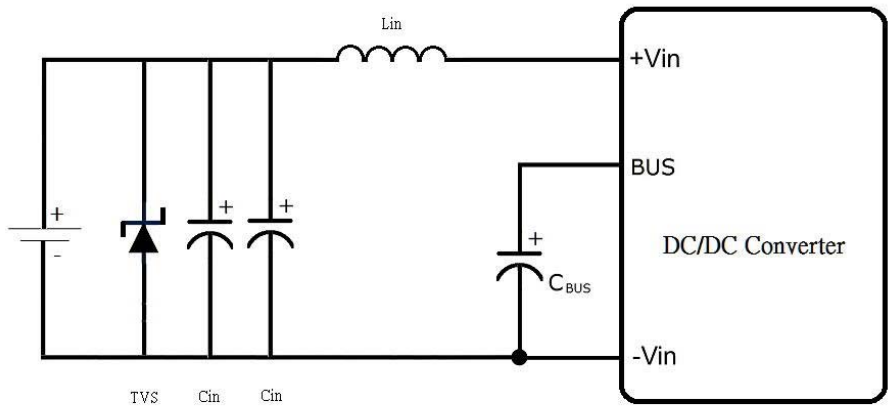
L1	L2	C2, C7	C1, C3, C9	C19, C21	C20, C22	C11, C13, C23, C24, C27, C28	C25, C29	C15, C17	C16, C18	TVS, CEMS, C4, C8, C10, C12, C26, C30,
545μH	4.7μH	150μF/ 200V	1μF/ 250V	680pF/ 250Vac	1000pF/ 250Vac	330pF/ 250Vac	100pF/ 250Vac	3300pF/ Y1	2200pF/ Y1	N/A

TEP 150-7218UIR/ TEP 150-72153UIR/ TEP 150-7218UIR-A/ TEP 150-72153UIR-A/
TEP 150-7218UIR-N/ TEP 150-72153UIR-N/ TEP 150-7218UIR-AN/ TEP 150-72153UIRAN

L1	L2	C2, C7	C1, C3, C9	C20, C22	C11, C13, C19, C21, C23, C24, C27, C28	C25, C29	C15, C17	C16, C18	TVS, CEMS, C4, C8, C10, C12, C26, C30,
545μH	4.7μH	150μF/ 200V	1μF/ 250V	680pF/ 250Vac	330pF/ 250Vac	100pF/ 250Vac	2200pF/ Y1	3300pF/ Y1	N/A

※ A C_{BUS} should always be installed and connected to the BUS pin for module's stability.
(C_{BUS}: 150μF/200V)

For Electrical Fast transient & Surge Immunity test requirements

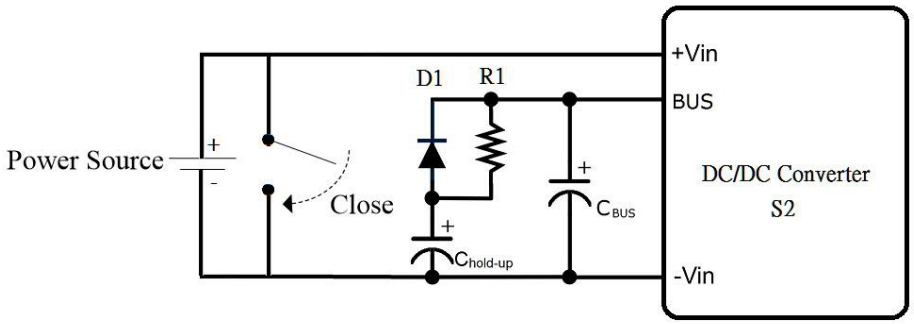


Model Reference	Increase countermeasure components
TEP 200UIR Series	With an external input filter Cin：150μF/200V * 2PCS TVS：170V/3000W Lin：3.3μH
TEP 150UIR Series	With an external input filter Cin：150μF/200V * 2PCS TVS：170V/3000W Lin：4.7μH

※ A C_{BUS} should always be installed and connected to the BUS pin for module's stability.
(C_{BUS}: 150μF/200V)

For Interruption voltage supply classes & supply change-over classes test requirements

Recommended external components for Interruptions of voltage supply Class S2

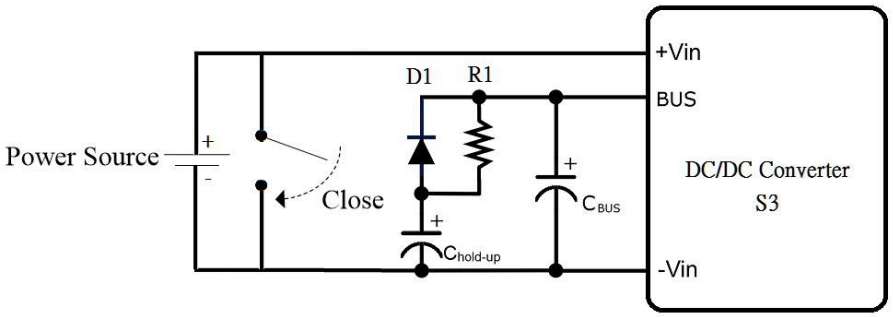


Model Reference	D1	R1	$C_{hold-up}$
TEP 200-7211UIR/ TEP 200-7211UIR-A/ TEP 200-7211UIR-N/ TEP 200-7211UIR-AN	200V/10A	100Ω/5W	3000μF
TEP 200-7212UIR/ TEP 200-7212UIR-A/ TEP 200-7212UIR-N/ TEP 200-7212UIR-AN			2400μF
TEP 200-7213UIR/ TEP 200-7213UIR-A/ TEP 200-7213UIR-N/ TEP 200-7213UIR-AN			3000μF
TEP 200-7215UIR/ TEP 200-7215UIR-A/ TEP 200-7215UIR-N/ TEP 200-7215UIR-AN			2400μF
TEP 200-7216UIR/ TEP 200-7216UIR-A/ TEP 200-7216UIR-N/ TEP 200-7216UIR-AN			3000μF
TEP 200-7218UIR/ TEP 200-7218UIR-A/ TEP 200-7218UIR-N/ TEP 200-7218UIR-AN			3000μF
TEP 200-72153UIR/ TEP 200-72153UIR-A/ TEP 200-72153UIR-N/ TEP 200-72153UIRAN			2400μF
TEP 150-7211UIR/ TEP 150-7211UIR-A/ TEP 150-7211UIR-N/ TEP 150-7211UIR-AN			2400μF
TEP 150-7212UIR/ TEP 150-7212UIR-A/ TEP 150-7212UIR-N/ TEP 150-7212UIR-AN			1800μF
TEP 150-7213UIR/ TEP 150-7213UIR-A/ TEP 150-7213UIR-N/ TEP 150-7213UIR-AN			2400μF

Model Reference	D1	R1	$C_{hold-up}$
TEP 150-7215UIR/ TEP 150-7215UIR-A/ TEP 150-7215UIR-N/ TEP 150-7215UIR-AN	200V/10A	100Ω/5W	1800μF
TEP 150-7216UIR/ TEP 150-7216UIR-A/ TEP 150-7216UIR-N/ TEP 150-7216UIR-AN			2400μF
TEP 150-7218UIR/ TEP 150-7218UIR-A/ TEP 150-7218UIR-N/ TEP 150-7218UIR-AN			2400μF
TEP 150-72153UIR/ TEP 150-72153UIR-A/ TEP 150-72153UIR-N/ TEP 150-72153UIRAN			1800μF

※ A C_{BUS} should always be installed and connected to the BUS pin for module's stability.
(C_{BUS}: 150μF/200V)

Recommended external components for Interruptions of voltage supply Class S3

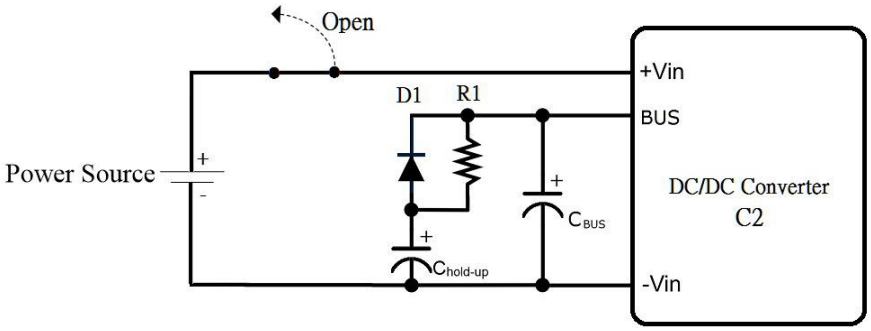


Model Reference	D1	R1	$C_{hold-up}$
TEP 200-7211UIR/ TEP 200-7211UIR-A/ TEP 200-7211UIR-N/ TEP 200-7211UIR-AN	200V/10A	100Ω/5W	6000μF
TEP 200-7212UIR/ TEP 200-7212UIR-A/ TEP 200-7212UIR-N/ TEP 200-7212UIR-AN			4800μF
TEP 200-7213UIR/ TEP 200-7213UIR-A/ TEP 200-7213UIR-N/ TEP 200-7213UIR-AN			6000μF
TEP 200-7215UIR/ TEP 200-7215UIR-A/ TEP 200-7215UIR-N/ TEP 200-7215UIR-AN			4800μF
TEP 200-7216UIR/ TEP 200-7216UIR-A/ TEP 200-7216UIR-N/ TEP 200-7216UIR-AN			6000μF
TEP 200-7218UIR/ TEP 200-7218UIR-A/ TEP 200-7218UIR-N/ TEP 200-7218UIR-AN			6000μF
TEP 200-72153UIR/ TEP 200-72153UIR-A/ TEP 200-72153UIR-N/ TEP 200-72153UIRAN			4800μF
TEP 150-7211UIR/ TEP 150-7211UIR-A/ TEP 150-7211UIR-N/ TEP 150-7211UIR-AN			4800μF
TEP 150-7212UIR/ TEP 150-7212UIR-A/ TEP 150-7212UIR-N/ TEP 150-7212UIR-AN			3600μF
TEP 150-7213UIR/ TEP 150-7213UIR-A/ TEP 150-7213UIR-N/ TEP 150-7213UIR-AN			4800μF

Model Reference	D1	R1	$C_{hold-up}$
TEP 150-7215UIR/ TEP 150-7215UIR-A/ TEP 150-7215UIR-N/ TEP 150-7215UIR-AN	200V/10A	100Ω/5W	3600μF
TEP 150-7216UIR/ TEP 150-7216UIR-A/ TEP 150-7216UIR-N/ TEP 150-7216UIR-AN			4800μF
TEP 150-7218UIR/ TEP 150-7218UIR-A/ TEP 150-7218UIR-N/ TEP 150-7218UIR-AN			4800μF
TEP 150-72153UIR/ TEP 150-72153UIR-A/ TEP 150-72153UIR-N/ TEP 150-72153UIRAN			3600μF

※ A C_{BUS} should always be installed and connected to the BUS pin for module's stability.
(C_{BUS}: 150μF/200V)

Recommended external components for supply change-over Class C2



Model Reference	D1	R1	$C_{hold-up}$
TEP 200-7211UIR/ TEP 200-7211UIR-A/ TEP 200-7211UIR-N/ TEP 200-7211UIR-AN	200V/10A	100Ω/5W	8800μF
TEP 200-7212UIR/ TEP 200-7212UIR-A/ TEP 200-7212UIR-N/ TEP 200-7212UIR-AN			6800μF
TEP 200-7213UIR/ TEP 200-7213UIR-A/ TEP 200-7213UIR-N/ TEP 200-7213UIR-AN			8800μF
TEP 200-7215UIR/ TEP 200-7215UIR-A/ TEP 200-7215UIR-N/ TEP 200-7215UIR-AN			6800μF
TEP 200-7216UIR/ TEP 200-7216UIR-A/ TEP 200-7216UIR-N/ TEP 200-7216UIR-AN			8800μF
TEP 200-7218UIR/ TEP 200-7218UIR-A/ TEP 200-7218UIR-N/ TEP 200-7218UIR-AN			8800μF
TEP 200-72153UIR/ TEP 200-72153UIR-A/ TEP 200-72153UIR-N/ TEP 200-72153UIRAN			6800μF
TEP 150-7211UIR/ TEP 150-7211UIR-A/ TEP 150-7211UIR-N/ TEP 150-7211UIR-AN			6800μF
TEP 150-7212UIR/ TEP 150-7212UIR-A/ TEP 150-7212UIR-N/ TEP 150-7212UIR-AN			4900μF
TEP 150-7213UIR/ TEP 150-7213UIR-A/ TEP 150-7213UIR-N/ TEP 150-7213UIR-AN			6800μF

Model Reference	D1	R1	$C_{hold-up}$
TEP 150-7215UIR/ TEP 150-7215UIR-A/ TEP 150-7215UIR-N/ TEP 150-7215UIR-AN	200V/10A	100Ω/5W	4900μF
TEP 150-7216UIR/ TEP 150-7216UIR-A/ TEP 150-7216UIR-N/ TEP 150-7216UIR-AN			6800μF
TEP 150-7218UIR/ TEP 150-7218UIR-A/ TEP 150-7218UIR-N/ TEP 150-7218UIR-AN			6800μF
TEP 150-72153UIR/ TEP 150-72153UIR-A/ TEP 150-72153UIR-N/ TEP 150-72153UIRAN			4900μF

※ A C_{BUS} should always be installed and connected to the BUS pin for module's stability.
(C_{BUS}: 150μF/200V)

1.4 Description of Support Equipment

For EMI test Configuration Support unit: 1~2
For EMS test Configuration Support unit: 1~3

No	Unit	Model Serial No.	Brand	Power Cord	FCC ID
1	DC Power Source	GPD-4050D S/N: N/A	GW INSTEK	Non-shielded	FCC DOC
2	Dummy Load	N/A S/N: N/A	N/A	N/A	N/A
3	DC Voltage meter	BN-670 S/N: N/A	Bonny	N/A	N/A

2. Characteristic Test

2.1 Visual Inspection and Performance test

2.1.1 Requirement:

The visual inspection shall be carried out to ensure that the equipment construction meets its specified requirements.

The performance test verifies the functional requirements of the Electronic Equipment. The performance test is carried out according to the Performance test specification and Performance test procedure written by the supplier either for type test or for routine test.

2.1.2 Test Procedure

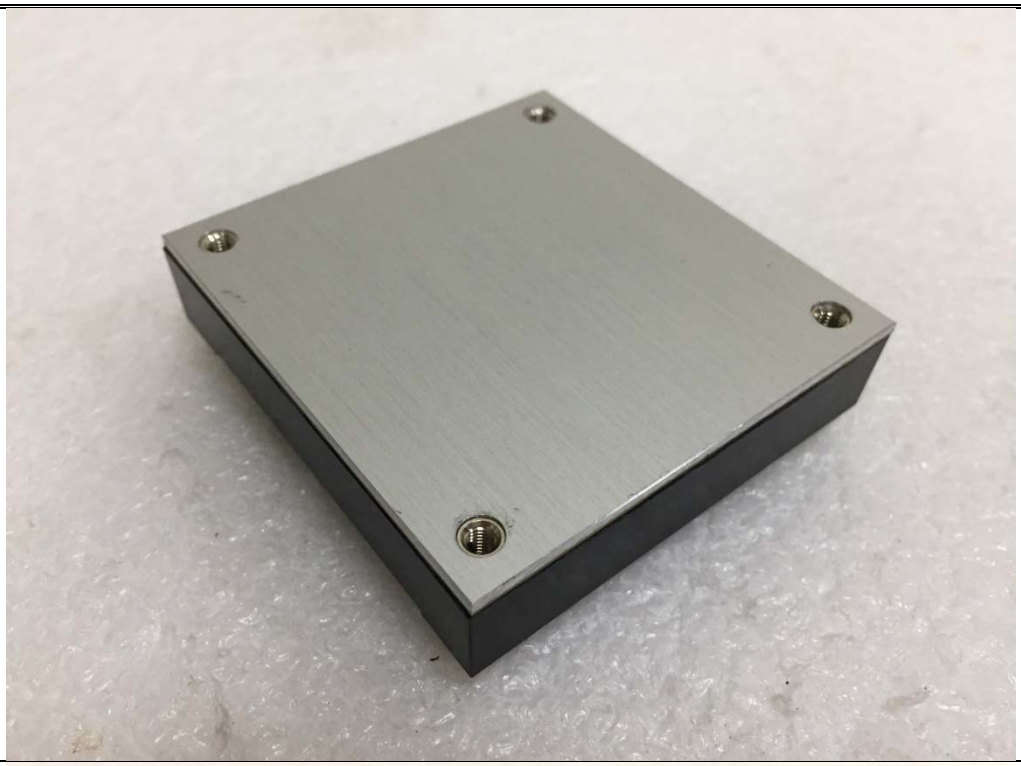
Test Procedures were referred to EN 50155 sub-clause 13.4.1 and 13.4.2

2.1.3 Test Result

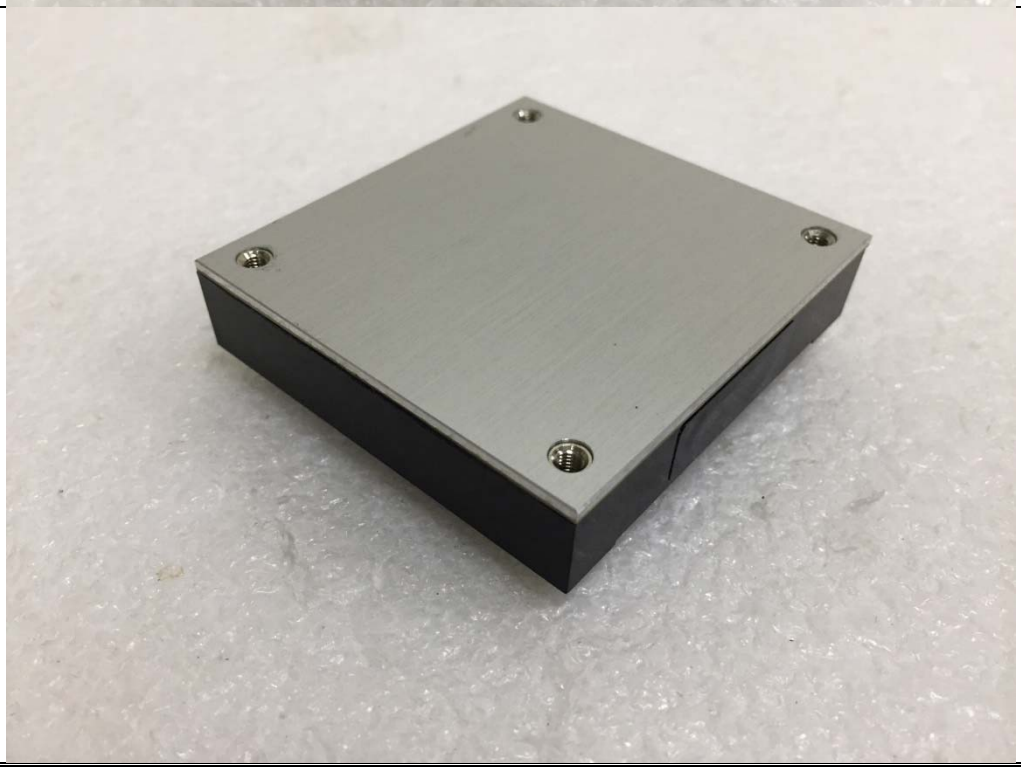
Date : 2021/05/31	Temperature : 25 ℃	Engineer : SAWYER
EUT Model Name: TEP 200-7213UIR-N	Humidity : 56 %	Barometer Pressure: 99.1 kPa
		Standard: EN 50155
Voltage/Freq: 72Vdc		
Visual inspection requirement:		
The visual inspection shall be carried out to ensure that the equipment is of sound construction and, so far as can be ascertained, meets its specified requirements. A visual inspection shall also be carried out after a type test has been performed to check whether any damage or deterioration has occurred resulting from the tests.		

Inspection item	Result
EUT outside	OK
EUT function	OK

Before test：Ok

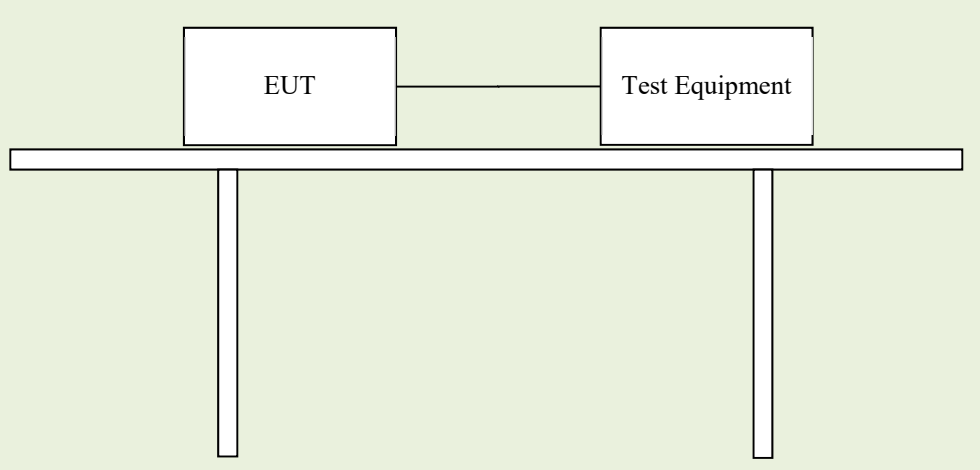



+Vo
+Sense
Trim
-Sense
-Vo
+Vin
Ctrl
Pulse Out
UVLO
BUS
-Vin



2.2 Power supply test (Supply variation and temporary supply dips)

2.2.1 Test Setup



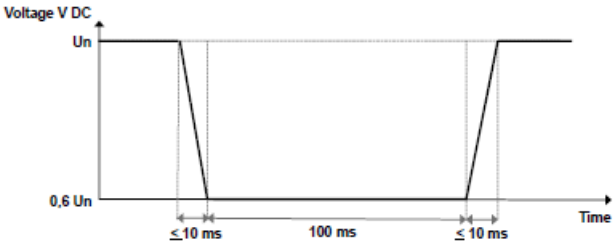
2.2.2 Test Procedure

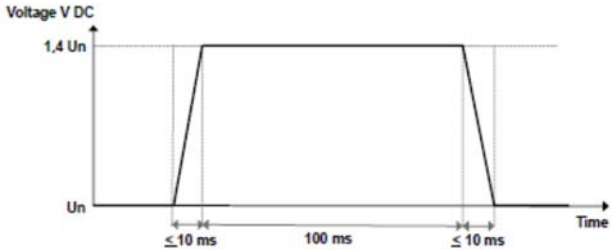
Test Procedures were referred to EN 50155 sub-clause 13.4.3.2, 13.4.3.3, 5.1.1.2 & 5.1.1.3

2.2.3 Test Requirement

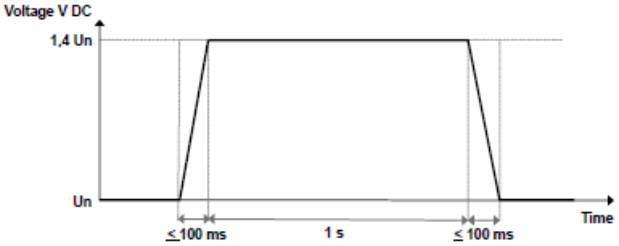
☒D.C. supplied equipment:
Test performed to prove correct functioning at nominal supply voltage and at the upper and lower limits of specified voltage as defined below:
Minimum Continuous voltage: 0.7 *Un* Maximum Continuous voltage: 1.25 *Un*

Voltage fluctuations (e.g. during start-up of auxiliary equipment or voltage oscillations of battery chargers) lying between 0.6 *Un* and 1.4 *Un* and not exceeding 0.1 s shall not cause deviation of function (performance criterion A).





For temporary supply overvoltages up to 1,4 *Un* lasting no more than 1 s the equipment shall fulfil performance criterion B.



☐A.C. supplied equipment:
Test performed to prove correct functioning at:
Nominal voltage and frequency;
The upper and lower limits of voltage and frequency are in all combinations.

2.2.4 Test Result

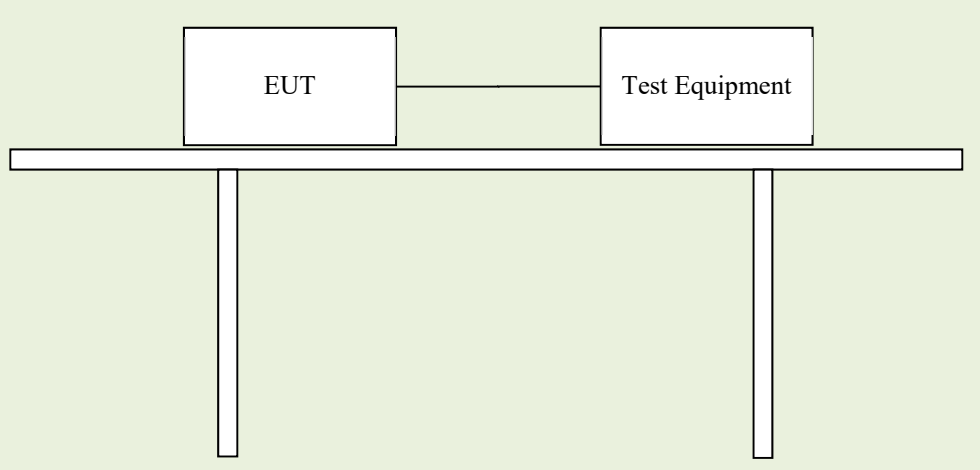
Date : 2021/7/4	Temperature : 26 ℃	Engineer : SAWYER
EUT Model Name : TEP 200-7213UIR-N	Humidity : 55 %	Barometer Pressure: 103.2 kPa
		Standard: EN 50155

Voltage/Freq: 72Vdc

Variations of Voltage supply	Level	Voltage	Test Time	EUT Status	Comments
Minimum voltage	0.7 Un	50.4Vdc	10 min	Pass	
Nominal voltage	Un	72Vdc	10 min	Pass	
Maximum voltage	1.25 Un	90Vdc	10 min	Pass	
Voltage fluctuations	Level	Voltage	Test Time	EUT Status	Comments
High voltage	1.4 Un	100.8Vdc	0.1 s	Pass	
Low voltage	0.6 Un	43.2Vdc	0.1 s	Pass	
High voltage	1.4 Un	100.8Vdc	1 s	Pass	
High voltage	1.25 Un	90Vdc	1 s	Pass	

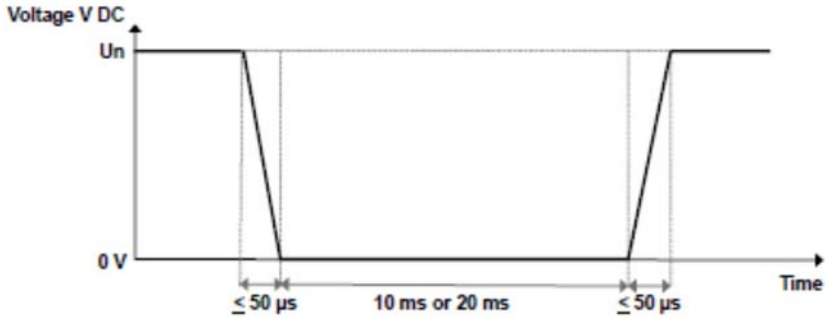
2.3 Power supply test (Supply Interruption)

2.3.1 Test Setup



2.3.2 Test Procedure

Test Procedures were referred to EN 50155 sub-clause 13.4.3.4 & 5.1.1.2



2.3.3 Test Requirement

Interruptions of input voltage as defined below:

Class	Requirements	Duration of the interruption time Tint
S1	No performance criterion is requested but the equipment shall continue to operate as specified after the voltage interruption.	This test is not required.
S2	The equipment shall behave according performance criterion A.	10 ms
S3	The equipment shall behave according performance criterion A.	20 ms

2.3.4 Test Result

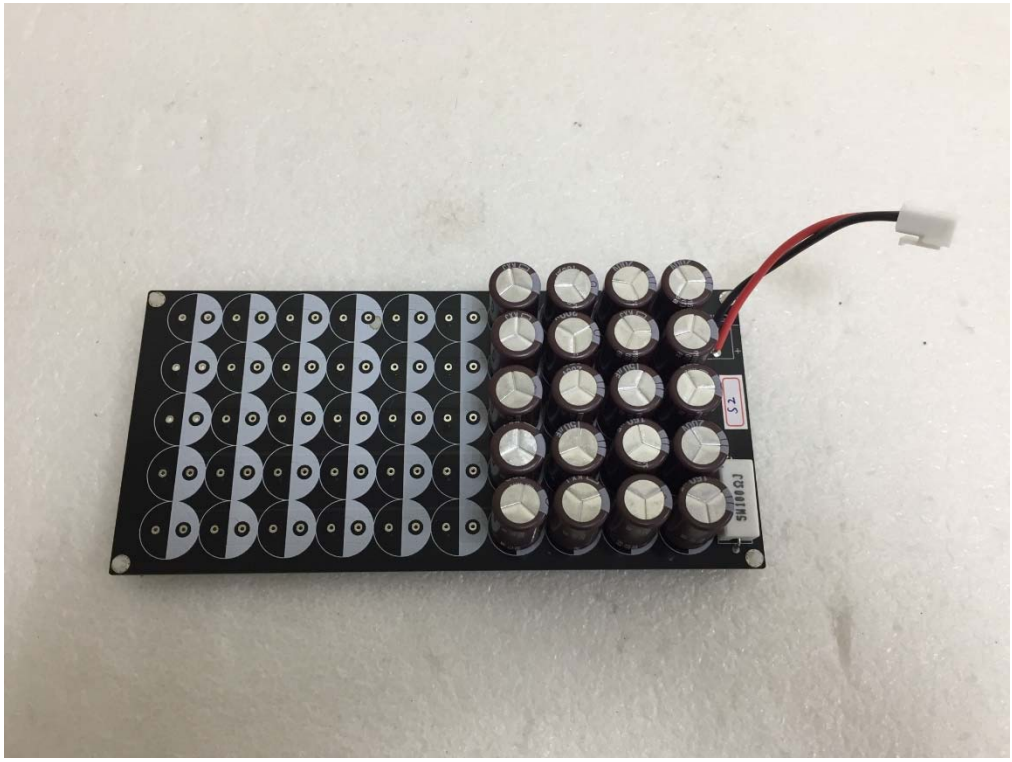
Date : 2021/7/4	Temperature : 26 ℃	Engineer : SAWYER
EUT Model Name : TEP 200-7213UIR-N	Humidity : 55 %	Barometer Pressure: 103.2 kPa
		Standard: EN 50155

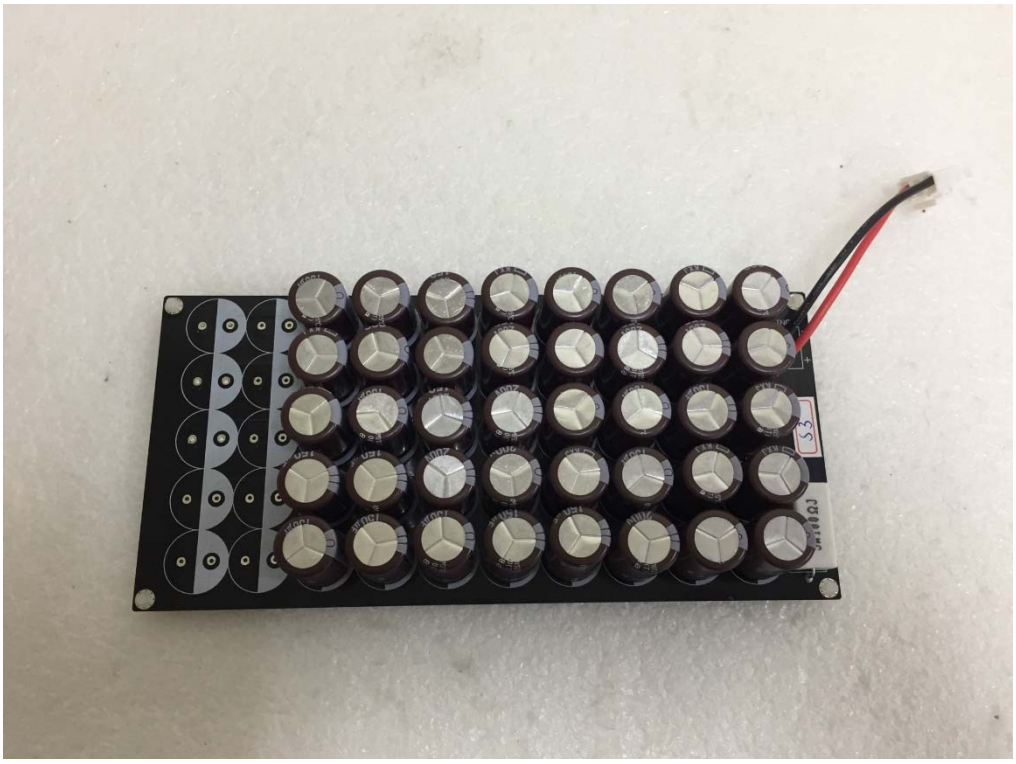
Voltage/Freq: 72Vdc

Interruptions of voltage supply	Level	Voltage	INT time	EUT Status	Comments
Class S1:Voltage interruptions	Un	72Vdc	0 s	Pass	
Class S2:Voltage interruptions	0 Un	0Vdc	10ms	Pass	Note
Class S3:Voltage interruptions	0 Un	0Vdc	20ms	Pass	Note

NOTE:
For the countermeasure components, please refer to Solution:" For Interruption voltage supply classes test requirements"

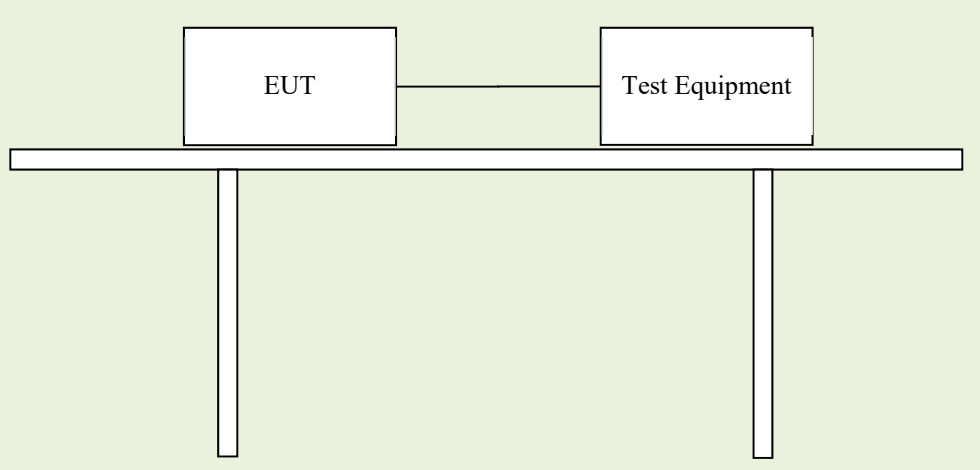
The following photos





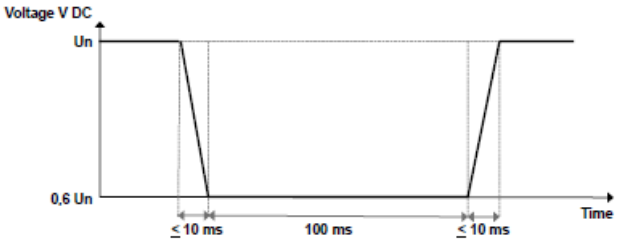
2.4 Power supply test (Supply Change Over)

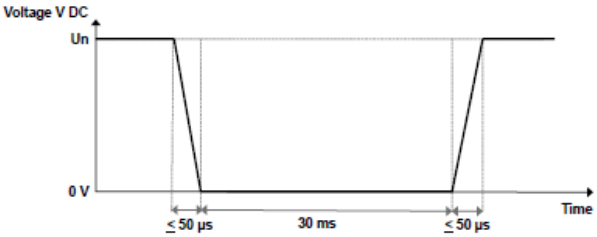
2.4.1 Test Setup



2.4.2 Test Procedure

Test Procedures were referred to EN 50155 sub-clause 13.4.3.5 & 5.1.3





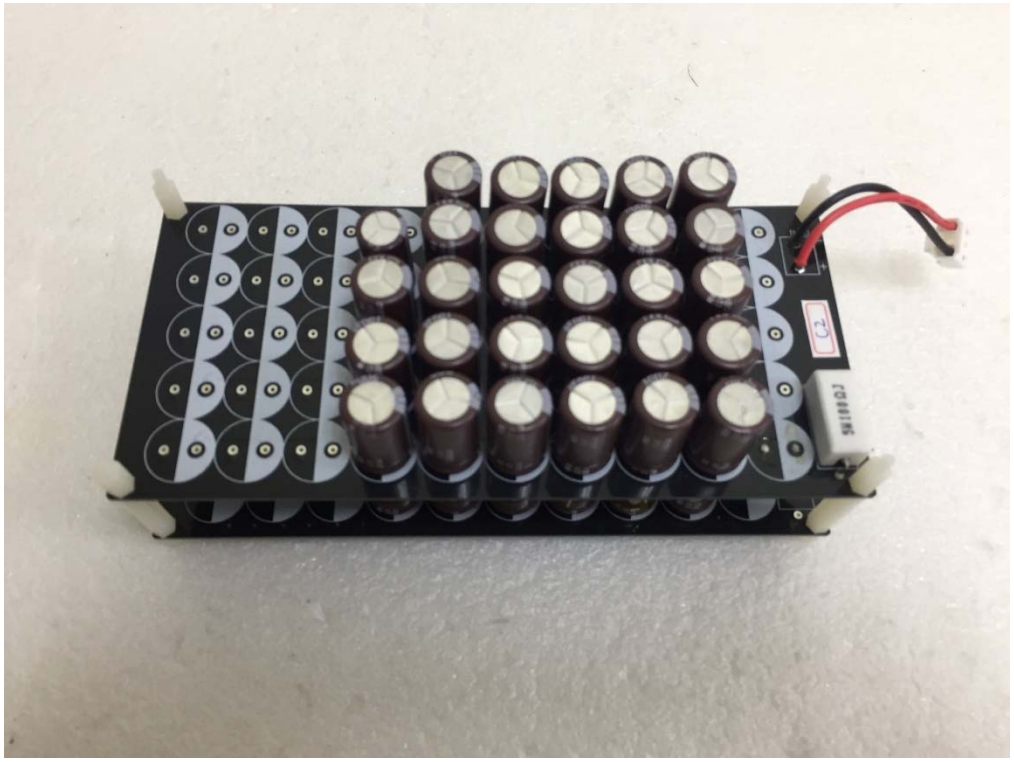
2.4.3 Test Requirement

- Class C1 at 0.6 *Un* during 100ms (without interruptions) **Performance criterion A;**
- Class C2: during a supply break of 30 ms starting at *Un* **Performance criterion B.**

2.4.4 Test Result

Date : 2021/7/4	Temperature : 26 ℃	Engineer : SAWYER
EUT Model Name : TEP 200-7213UIR-N	Humidity : 55 %	Barometer Pressure: 103.2 kPa
		Standard: EN 50155

Voltage/Freq: 72Vdc					
Supply change over	Level	Voltage	INT time	EUT Status	Comments
Class C1:60% residual voltage	0.6 Un	43.2Vdc	100ms	Pass	
Class C2:0% residual voltage	0 Un	0Vdc	30ms	Pass	Note1
NOTE: For the countermeasure components, please refer to Solution:" For supply change-over classes test requirements"					
The following photos					



2.5 Insulation Test

2.5.1 Test Procedure

Test Procedures were referred to EN 50155 sub-clause 13.4.9

2.5.2 Test Requirement

☒**Insulation measurement Test: 500VDC**
The insulation resistance test carried out at 500 VDC and the values recorded.
The test repeated after the voltage withstand test.
Test acceptance requirements:
There shall be no fundamental deterioration from the initial measurement.

☒**Voltage withstand test:**

Nominal battery voltages and/or I/O voltage	Test Voltage
$<$ 72Vdc or 50Vac $_{rms}$	500Vac or 750Vdc
72Vdc $\leqq$ Vdc $<$ 125Vdc or from 50 to 90 Vac $_{rms}$	1000Vac or 1500Vdc
125Vdc $\leqq$ Vdc $<$ 315Vdc or from 90 to 225 Vac $_{rms}$	1500Vac or 2200Vdc

Test acceptance requirements:
Neither disruptive discharge nor flashover shall occur.

2.5.3 Test Result

Date : 2021/08/09	Temperature :22.3 ℃	Engineer : Jimmy Wen
EUT Model Name : TEP 200-7213UIR-N	Humidity : 58.6 %	Equipment: SE 7452, TH110-POSE,
	Barometer Pressure: 99.2 kPa	Standard: EN 50155 insulation test

Insulation Test Requirement:

1.Insulation measurement Test :

The insulation resistance test shall be carried out at 500 Vdc and the values recorded.
The test shall then be repeated after the voltage withstand test.
There shall be no fundamental deterioration from the initial measurement.

Test item	Test Time	Insulation measurement test		Comments
		before withstand	after withstand	
Primary side to secondary side	1 min	50GΩ	50GΩ	Pass
Primary side to secondary side	1 min	50GΩ	20.338GΩ	Pass

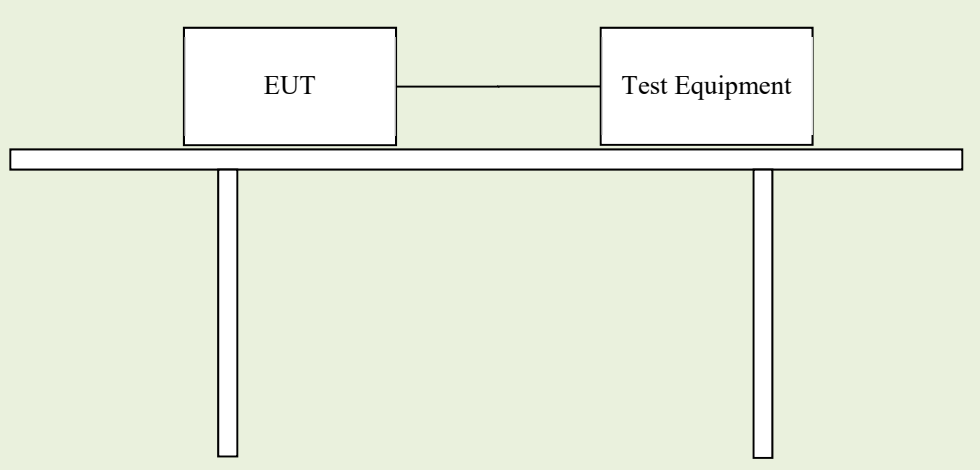
2.Voltage Withstand test

500Vac or 750Vdc for nominal battery voltages below 72 Vdc (or 50 Vac).
1000Vac or 1500Vdc for nominal battery voltage from 72Vdc up to 125Vdc, (or from 50 to 90 Vac), and
1500Vac or 2200Vdc for nominal battery voltage above 125Vdc and up to 315Vdc, (or from 90 to 225 Vac).
Neither disruptive discharge nor flashover shall occur

Test item	Test Voltage	Test Time	Result	Comments
Primary side to secondary side	1000Vac	1 min	0.382mA	Pass
Primary side to secondary side	3000Vac	1 min	0.973mA	Pass

2.6 DC ripple factor

2.6.1 Test Setup



2.6.2 Test Procedure

Test Procedures were referred to EN 50155 sub-clause 5.1.1.6

2.6.3 Test Requirement

Test performed to prove correct functioning at nominal supply voltage and at the upper and lower limits of specified voltage as defined below:

$$\text{DC Ripple Factor (\%)} = \frac{U_{max} - U_{min}}{2U_n} \times 100 \text{ approximately } \frac{U_{max} - U_{min}}{2U_{max} + U_{min}U_n} \times 100$$

Maximum Peak to Peak Voltages with a DC Ripple Factor of 5 % as defined below:

Nominal Voltage (U_n)	Maximum Peak to Peak ripple allowed (V)	Umax (V)	Umin (V)	DC Ripple factor (%)
24	2,4	25,2	22,8	5 %
36	3,6	37,8	34,2	5 %
48	4,8	50,4	45,6	5 %
72	7,2	75,6	68,4	5 %
96	9,6	100,8	91,2	5 %
110	11	115,5	104,5	5 %

2.6.4 Test Result

Date : 2021/7/4		Temperature : 26 ℃		Engineer : SAWYER	
EUT Model Name : TEP 200-7213UIR-N		Humidity : 55 %		Barometer Pressure: 103.2 kPa	
				Standard: EN 50155	
Voltage/Freq: 72Vdc					
Nominal Voltage(Un)	Umax(V)	Umin(V)	DC Ripple factor (%)	EUT Status	Comments
72	75.6	68.4	5%	Pass	

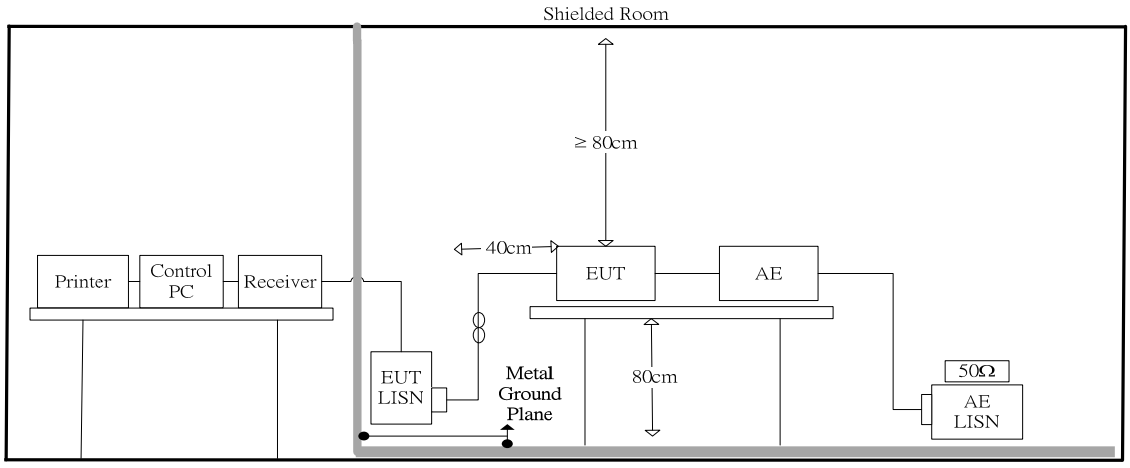
3. Electromagnetic Compatibility (EMC)

Test Procedures were referred to EN 50155 sub-clause 13.4.8.
All EMC tests of the electronic equipment shall be carried out according EN 50121-3-2.

3.1 Power Main Port Conducted Emissions

3.1.1 Test Setup and Procedure

3.1.2 Test Setup



3.1.3 Test Procedure

The measurements are performed in a shielded room site; The EUT was placed on non-conduction 1.0m x 1.5m table, which is 0.8 meters above an earth-grounded.

Power to the EUT was provided through the LISN which has the Impedance (50ohm/50uH) vs. Frequency Characteristic in accordance with the standard. Powers to the LISNs were filtered to eliminate ambient signal interference and these filters were bonded to the ground plane. Peripheral equipment required to provide a functional system (support equipment) for EUT testing was powered from the second LISN through a ganged, metal power outlet box which is bonded to the ground plane at the LISN.

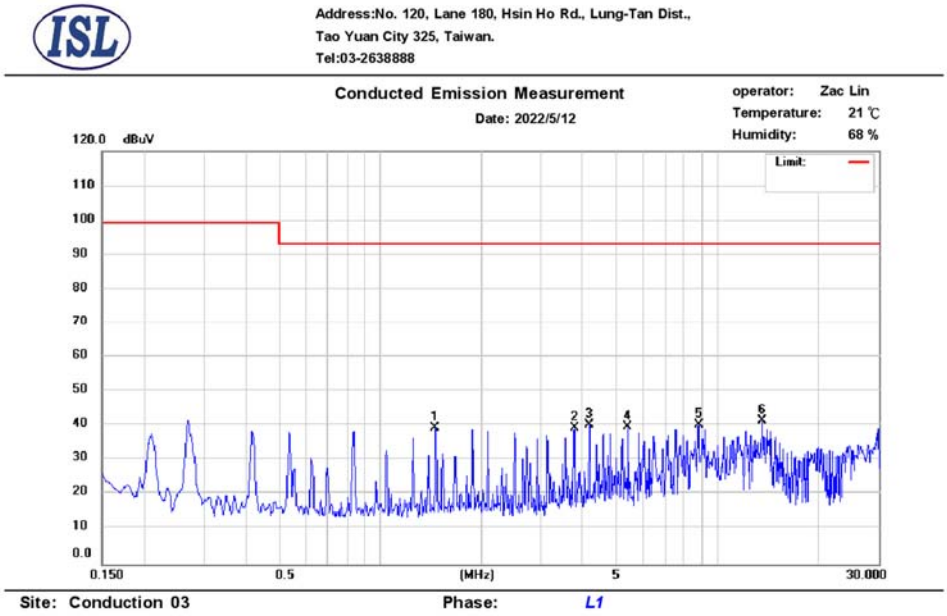
The interconnecting cables were arranged and moved to get the maximum measurement. Both the line of power cord, hot and neutral, were measured. All of the interface cables were manipulated according to EN 55016-2-1 / CISPR 16-2-1 requirements.

The highest emissions were analyzed in details by operating the spectrum analyzer in fixed tuned mode to determine the nature of the emissions and to provide information which could be useful in reducing their amplitude.

3.1.4 EMI Receiver/Spectrum Analyzer Configuration (for the frequencies tested)

Frequency Range:	150KHz--30MHz
Detector Function:	Quasi-Peak Mode
Resolution Bandwidth:	9KHz

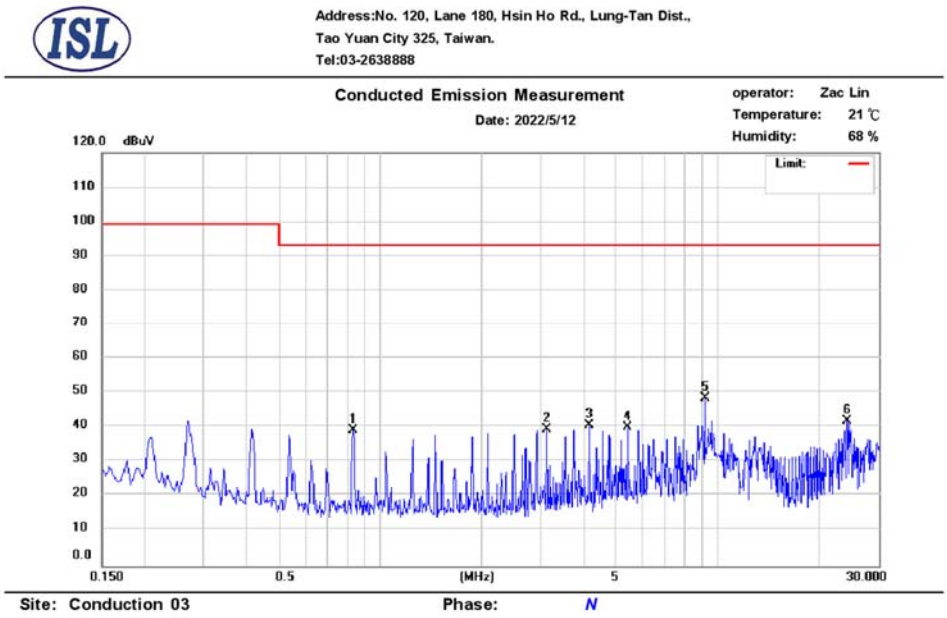
Conduction Test Data: Configuration 1
-Live



No.	Frequency (MHz)	QP_R (dBuV)	Correct Factor (dB)	QP Emission (dBuV)	QP Limit (dBuV)	QP Margin (dB)
1	1.462	27.91	10.20	38.11	93.00	-54.89
2	3.766	0.75	10.30	11.05	93.00	-81.95
3	4.178	21.37	10.30	31.67	93.00	-61.33
4	5.434	2.11	10.35	12.46	93.00	-80.54
5	8.778	6.10	10.47	16.57	93.00	-76.43
6	13.598	7.13	10.61	17.74	93.00	-75.26

Note:
Margin = QP Emission – Limit
QP Emission = QP_R + Correct Factor
Correct Factor = LISN Loss + Cable Loss

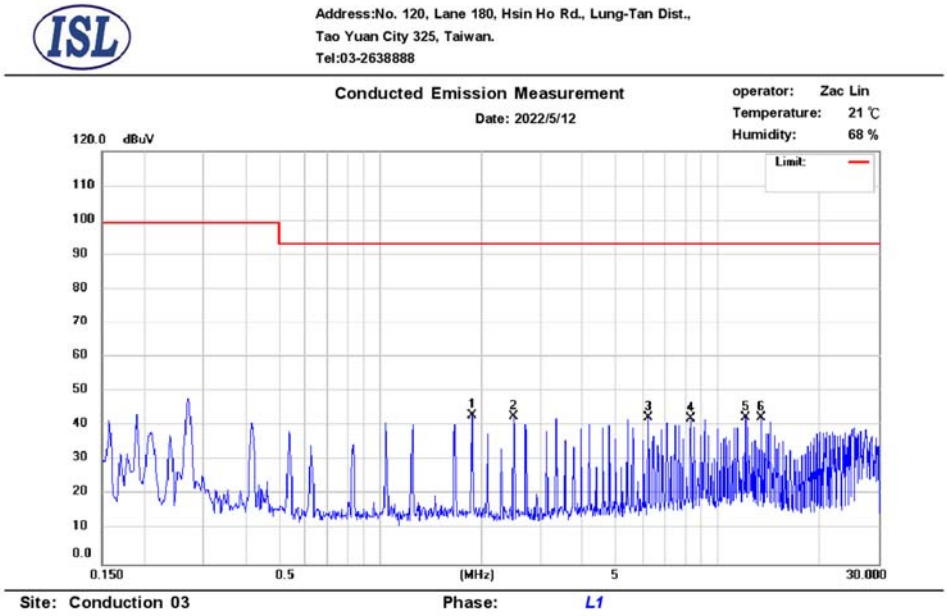
-Neutral



No.	Frequency (MHz)	QP_R (dBuV)	Correct Factor (dB)	QP Emission (dBuV)	QP Limit (dBuV)	QP Margin (dB)
1	0.834	27.69	10.21	37.90	93.00	-55.10
2	3.126	25.80	10.32	36.12	93.00	-56.88
3	4.166	28.93	10.35	39.28	93.00	-53.72
4	5.422	8.23	10.40	18.63	93.00	-74.37
5	9.174	12.24	10.52	22.76	93.00	-70.24
6	24.182	2.37	10.91	13.28	93.00	-79.72

Note:
Margin = QP Emission – Limit
QP Emission = QP_R + Correct Factor
Correct Factor = LISN Loss + Cable Loss

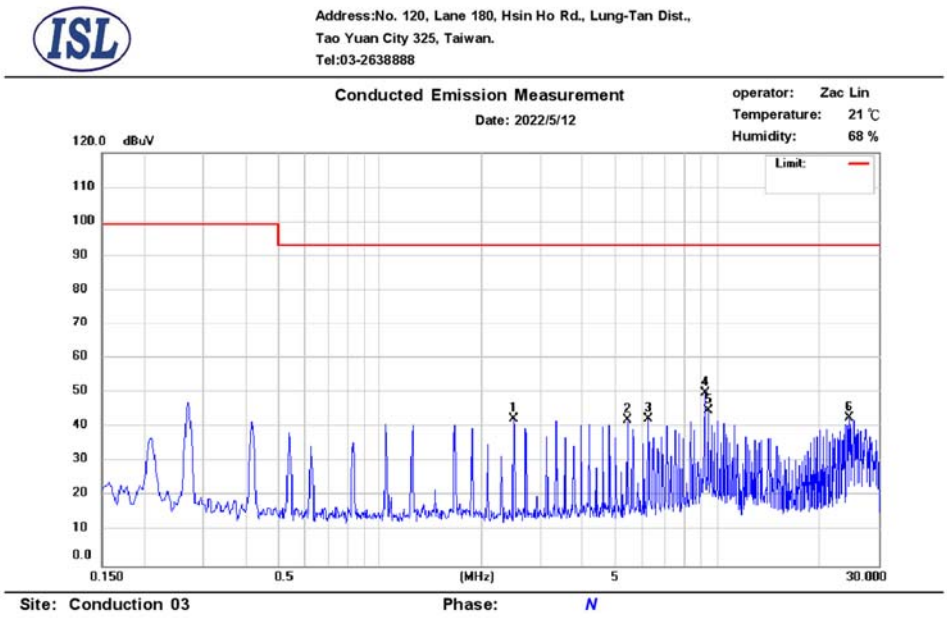
Conduction Test Data: Configuration 2
-Live



No.	Frequency (MHz)	QP_R (dBuV)	Correct Factor (dB)	QP Emission (dBuV)	QP Limit (dBuV)	QP Margin (dB)
1	1.874	32.26	10.24	42.50	93.00	-50.50
2	2.498	31.81	10.26	42.07	93.00	-50.93
3	6.246	31.50	10.37	41.87	93.00	-51.13
4	8.326	30.70	10.45	41.15	93.00	-51.85
5	12.074	30.87	10.57	41.44	93.00	-51.56
6	13.530	29.88	10.61	40.49	93.00	-52.51

Note:
Margin = QP Emission – Limit
QP Emission = QP_R + Correct Factor
Correct Factor = LISN Loss + Cable Loss

-Neutral



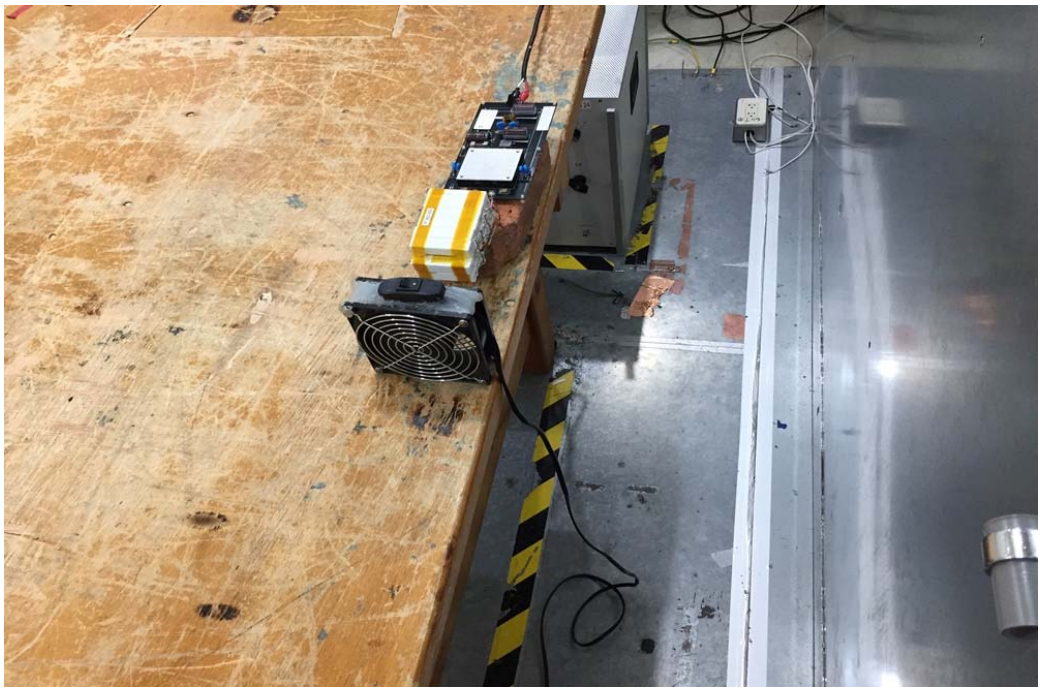
No.	Frequency (MHz)	QP_R (dBuV)	Correct Factor (dB)	QP Emission (dBuV)	QP Limit (dBuV)	QP Margin (dB)
1	2.498	31.56	10.30	41.86	93.00	-51.14
2	5.414	31.39	10.40	41.79	93.00	-51.21
3	6.246	31.40	10.42	41.82	93.00	-51.18
4	9.162	38.90	10.52	49.42	93.00	-43.58
5	9.370	33.99	10.54	44.53	93.00	-48.47
6	24.570	31.00	10.93	41.93	93.00	-51.07

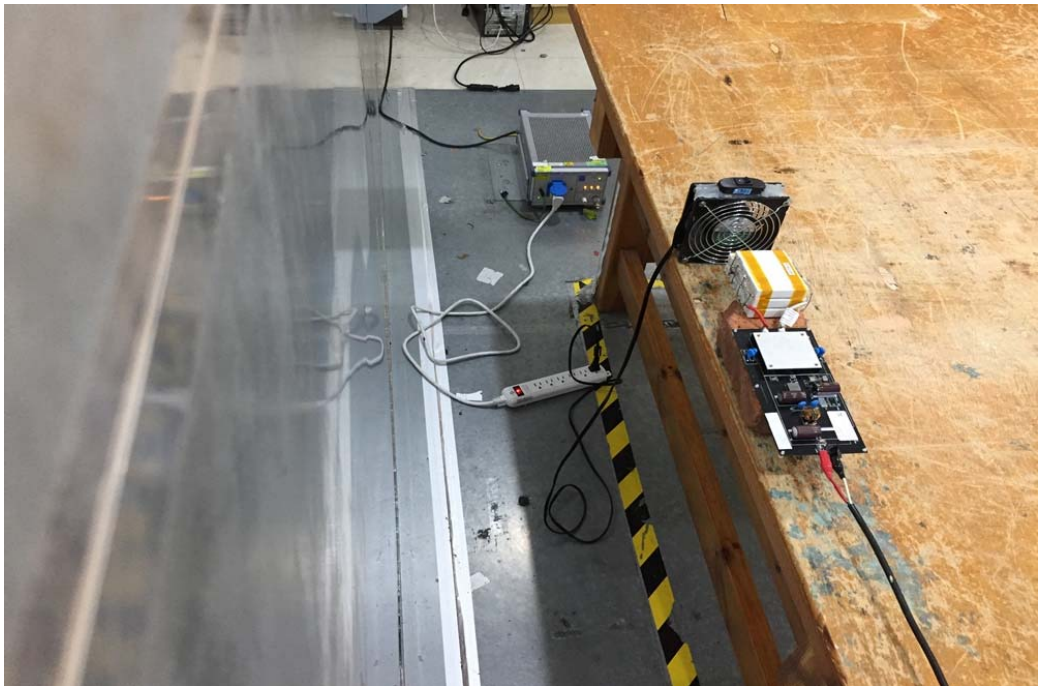
Note:
Margin = QP Emission – Limit
QP Emission = QP_R + Correct Factor
Correct Factor = LISN Loss + Cable Loss

3.1.5 Test Setup Photo

Front View

Back View

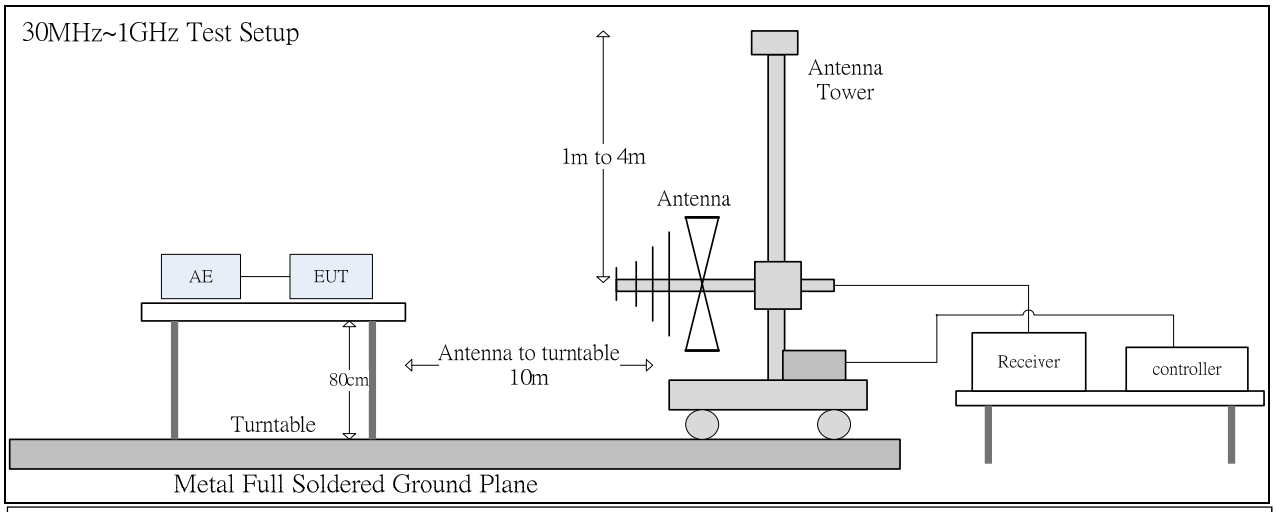


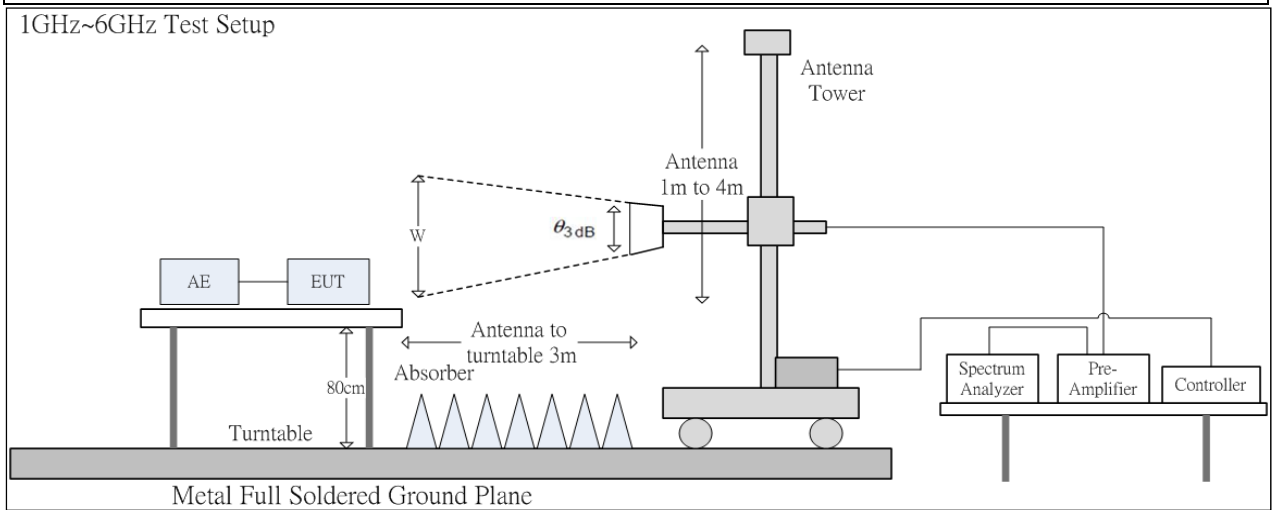


3.2 Radiated Disturbance Emissions

3.2.1 Test Setup and Procedure

3.2.2 Test Setup





The 3dB beam width of the horn antenna used for the test is as shown in the table below.

Frequency (GHz)	E-plane	H-plane	$\theta_{3\,dB}$ (min)	d= 3 m
				w (m)
1	88°	147°	88°	5.79
2	68°	119°	68°	4.04
3	73°	92°	73°	4.44
4	70°	89°	70°	4.20
5	55°	60°	55°	3.12
6	63°	62°	62°	3.60

3.2.3 Test Procedure

The radiated emissions test will then be repeated on the open site or chamber to measure the amplitudes accurately and without the multiple reflections existing in the shielded room. The EUT and support equipment are set up on the turntable of one of 10 meter open field sites or 10 meter chamber. Desktop EUT are set up on a wooden stand 0.8 meter above the ground or floor-standing arrangement shall be placed on the horizontal ground reference plane. The test volume for a height of up to 30 cm may be obstructed by absorber placed on the ground plane.

For the initial measurements, the receiving antenna is varied from 1-4 meter height and is changed in the vertical plane from vertical to horizontal polarization at each frequency. The highest emissions between 30 MHz to 1000 MHz were analyzed in details by operating the spectrum analyzer and/or EMI receiver in quasi-peak mode to determine the precise amplitude of the emissions. The highest emissions between 1 GHz to 6 GHz were analyzed in details by operating the spectrum analyzer in peak and average mode to determine the precise amplitude of the emissions.

At the highest amplitudes observed, the EUT is rotated in the horizontal plane while changing the antenna polarization in the vertical plane to maximize the reading. The interconnecting cables were arranged and moved to get the maximum measurement. Once the maximum reading is obtained, the antenna elevation and polarization will be varied between specified limits to maximize the readings. All of the interface cables were manipulated according to EN 61000-6-4 / BS EN 61000-6-4 requirements.

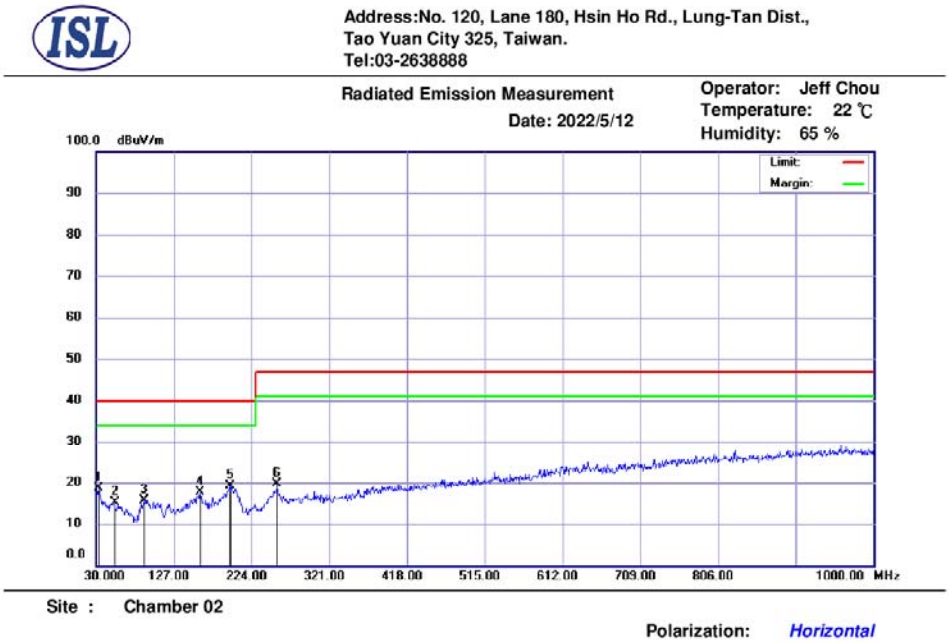
The highest internal source of an EUT is defined as the highest frequency generated or used within the EUT or on which the EUT operates or tunes. If the highest frequency of the internal sources of the EUT is less than 108 MHz, the measurement shall only be made up to 1 GHz. If the highest frequency of the internal sources of the EUT is between 108 MHz and 500 MHz, the measurement shall only be made up to 2 GHz. If the highest frequency of the internal sources of the EUT is between 500 MHz and 1 GHz, the measurement shall only be made up to 5 GHz. If the highest frequency of the internal sources of the EUT is above 1 GHz, the measurement shall be made up to 5 times the highest frequency or 6 GHz, whichever is less.

3.2.4 Spectrum Analyzer Configuration (for the frequencies tested)

Frequency Range:	30MHz--1000MHz
Detector Function:	Quasi-Peak Mode
Resolution Bandwidth:	120KHz

Frequency Range:	Above 1 GHz to 6 GHz
Detector Function:	Peak / Average Mode
Resolution Bandwidth:	1MHz

Radiation Test Data: Configuration 1
-Horizontal

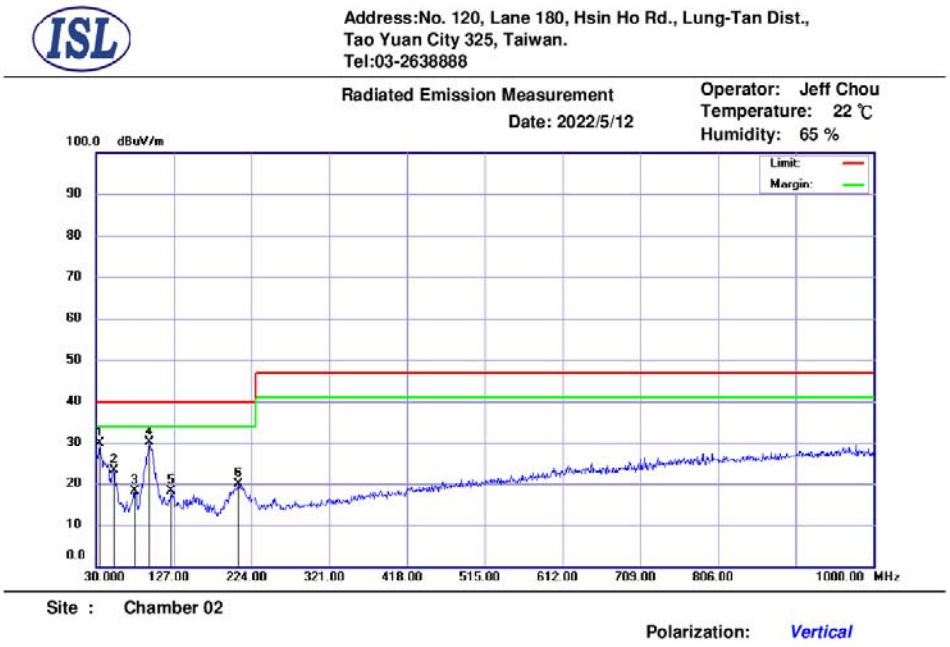


Mk.	Frequency (MHz)	RX_R (dBuV)	Correct Factor(dB/m)	Emission (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Ant.Pos (cm)	Tab.Pos (deg.)	Detector
1	32.91	37.69	-19.04	18.65	40.00	-21.35	400	263	peak
2	53.28	32.47	-17.26	15.21	40.00	-24.79	250	8	peak
3	90.14	38.42	-22.76	15.66	40.00	-24.34	400	202	peak
4	159.98	33.41	-15.75	17.66	40.00	-22.34	350	39	peak
5	197.81	37.73	-18.52	19.21	40.00	-20.79	300	173	peak
6	256.01	35.82	-16.24	19.58	47.00	-27.42	400	0	peak

* Note:
Margin = Emission – Limit
Emission = Radiated Amplitude + Correct Factor
Correct Factor = Antenna Correction Factor + Cable Loss

BILOG Antenna Distance: 10 meters

-Vertical

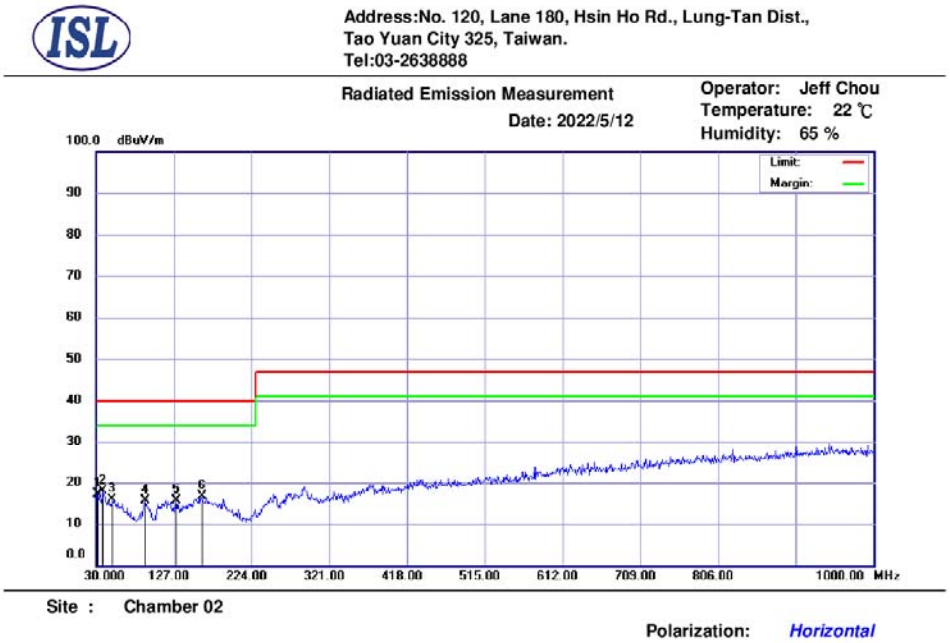


Mk.	Frequency (MHz)	RX_R (dBuV)	Correct Factor(dB/m)	Emission (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Ant.Pos (cm)	Tab.Pos (deg.)	Detector
1	33.88	48.66	-18.68	29.98	40.00	-10.02	100	360	peak
2	52.31	40.38	-17.20	23.18	40.00	-16.82	250	322	peak
3	78.50	39.14	-20.90	18.24	40.00	-21.76	250	121	peak
4	95.96	52.42	-22.18	30.24	40.00	-9.76	150	140	peak
5	124.09	36.24	-18.06	18.18	40.00	-21.82	100	121	peak
6	207.51	38.54	-18.72	19.82	40.00	-20.18	100	247	peak

* Note:
Margin = Emission – Limit
Emission = Radiated Amplitude + Correct Factor
Correct Factor = Antenna Correction Factor + Cable Loss

BILOG Antenna Distance: 10 meters

Radiation Test Data: Configuration 2
-Horizontal

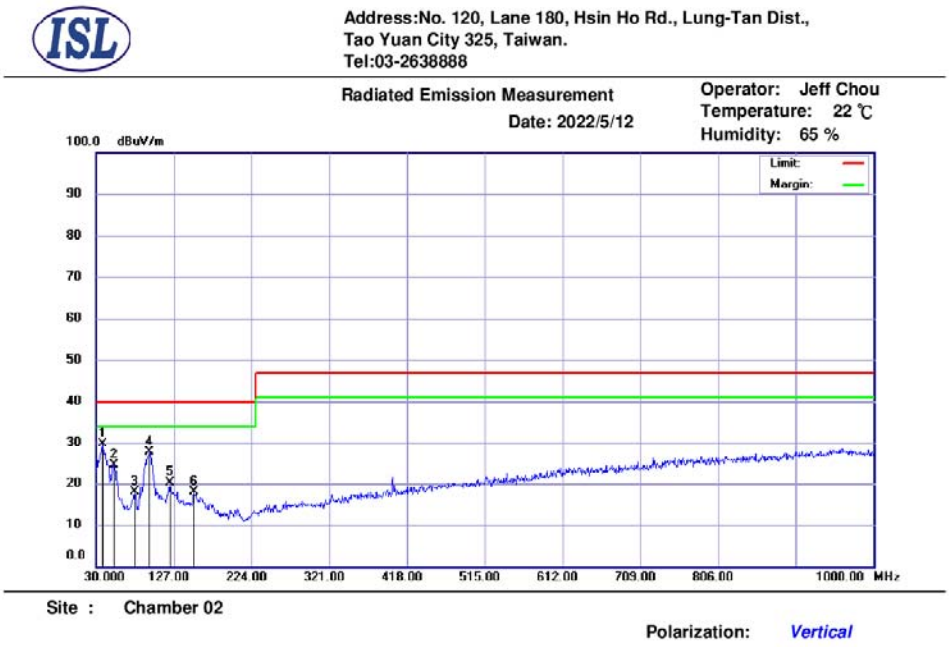


Mk.	Frequency (MHz)	RX_R (dBuV)	Correct Factor(dB/m)	Emission (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Ant.Pos (cm)	Tab.Pos (deg.)	Detector
1	31.94	36.07	-18.98	17.09	40.00	-22.91	400	62	peak
2	38.73	35.63	-17.75	17.88	40.00	-22.12	250	115	peak
3	50.37	32.93	-17.15	15.78	40.00	-24.22	200	88	peak
4	91.11	38.21	-22.65	15.56	40.00	-24.44	400	0	peak
5	129.91	33.08	-17.38	15.70	40.00	-24.30	350	182	peak
6	161.92	32.49	-15.81	16.68	40.00	-23.32	400	204	peak

* Note:
Margin = Emission – Limit
Emission = Radiated Amplitude + Correct Factor
Correct Factor = Antenna Correction Factor + Cable Loss

BILOG Antenna Distance: 10 meters

-Vertical



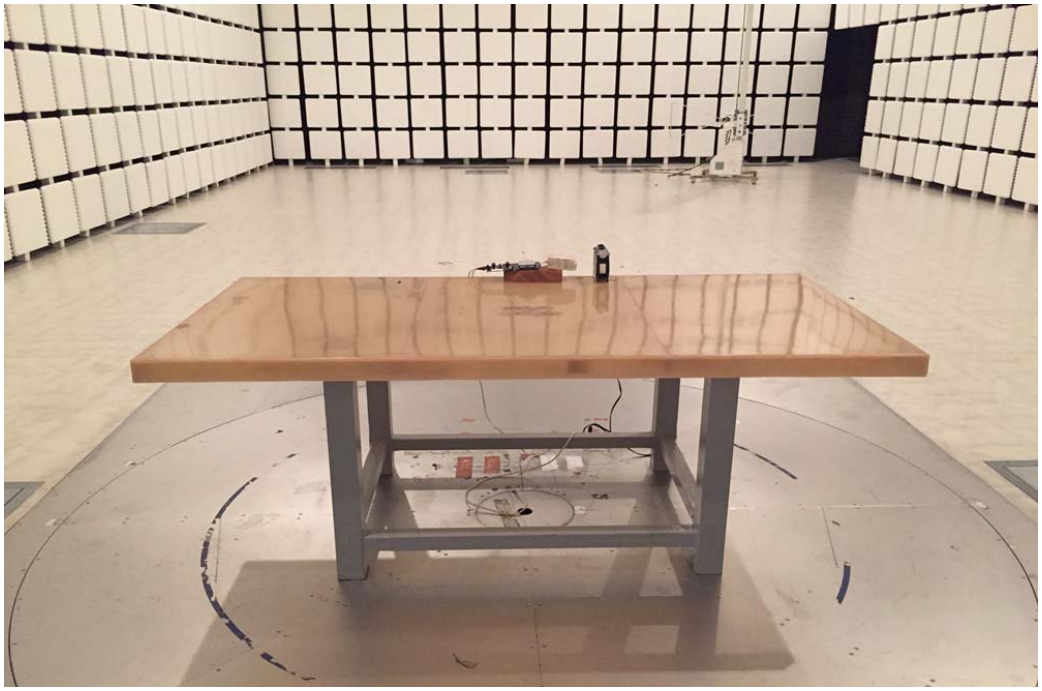
Mk.	Frequency (MHz)	RX_R (dBuV)	Correct Factor(dB/m)	Emission (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Ant.Pos (cm)	Tab.Pos (deg.)	Detector
1	37.76	47.77	-18.02	29.75	40.00	-10.25	370	360	peak
2	52.31	41.64	-17.20	24.44	40.00	-15.56	150	258	peak
3	78.50	38.73	-20.90	17.83	40.00	-22.17	150	172	peak
4	96.93	49.36	-21.79	27.57	40.00	-12.43	200	99	peak
5	122.15	38.35	-18.18	20.17	40.00	-19.83	386	360	peak
6	152.22	33.77	-15.95	17.82	40.00	-22.18	150	264	peak

* Note:
Margin = Emission – Limit
Emission = Radiated Amplitude + Correct Factor
Correct Factor = Antenna Correction Factor + Cable Loss

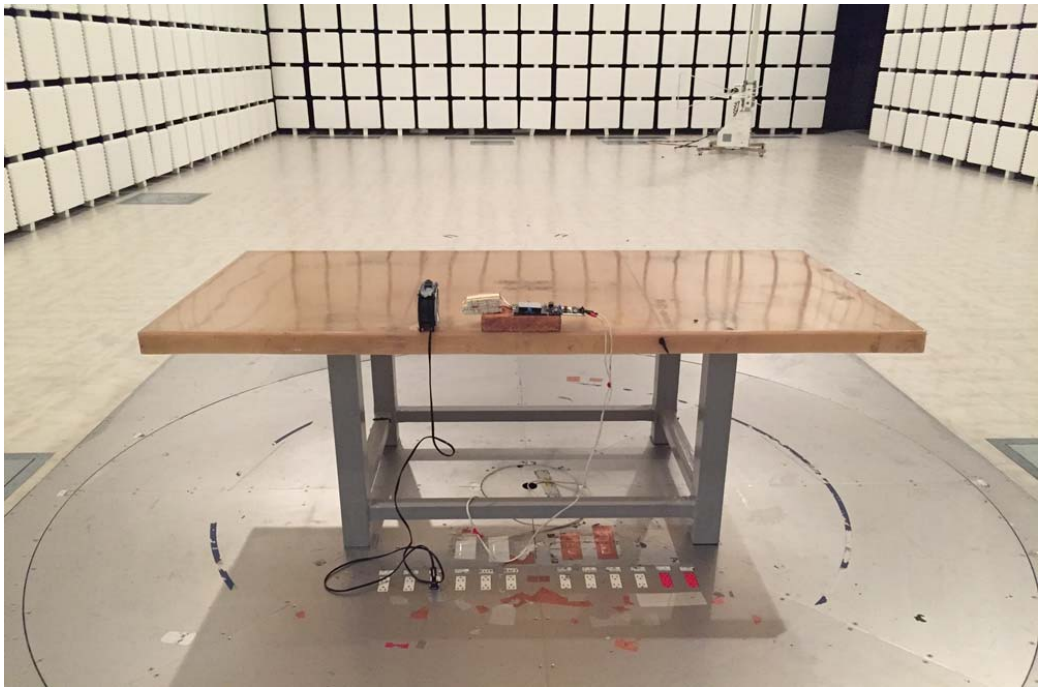
BILOG Antenna Distance: 10 meters

3.2.5 Test Setup Photo

Front View (30MHz~1GHz)



Back View (30MHz~1GHz)



3.3 Electrostatic discharge (ESD) immunity

3.3.1 Test Specification

Port:	Enclosure
Basic Standard:	EN 61000-4-2 / IEC EN61000-4-2 / BS EN 61000-4-2 (details referred to Sec 1.2)
Test Level:	Air +/- 2 kV, +/- 4 kV, +/- 6 kV, +/- 8 kV Contact +/- 4 kV, +/- 6 kV
Criteria:	B
Test Procedure:	refer to ISL QA -T4-E-S7

Selected Test Point

Air: discharges were applied to slots, aperture or insulating surfaces. 10 single air discharges were applied to each selected points.

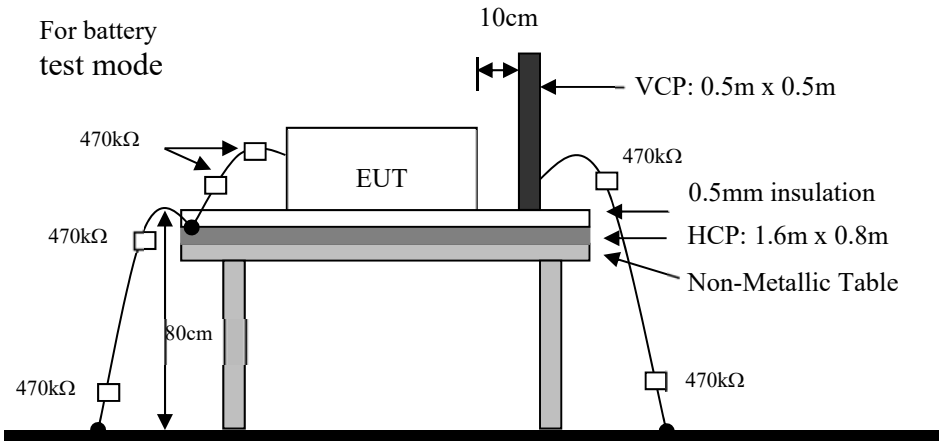
Contact: 10 discharges to the selected contact points.

Indirect Contact Points: 10 discharges were applied to center of one edge of VCP and each EUT side of HCP with 10 cm away from EUT.

Energy-Storage Capacitor:150 pF; Discharge Resistor:330 Ω

3.3.2 Test Setup

EUT is 1m from the wall and other metallic structure. When Battery test mode is needed, a cable with one 470kΩ resister at two rare ends is connected from metallic part of EUT and screwed to HCP.



3.3.3 Test Result

Performance of EUT complies with the given specification.

3.3.4 Test Data: Configuration 1

Basic Standard	EN 61000-4-2	Date
EUT Model Name	TEP 200-7213UIR-N	2021-06-21
		Engineer
Barometer Pressure	100.3kPa	Jeff Liang
Temperature	22℃	Equipment & Test Site
Humidity	40%	EM TEST(Model: Dito)
Voltage	72Vdc	ESD 1F

A=criteria A, B=criteria B, C=criteria C

→Blue arrow represent Air discharge point

→Red arrow represent Contact discharge point

ND=No Discharge, No Arcing; Meets criteria but unable to obtain an electrostatic discharge (ESD) at this test point.

X=EUT DOES NOT meet the acceptance criteria

A=criteria A, B=criteria B, C=criteria C

Contact Discharge	Voltage kV 25 Discharge @ 1 PPS										
Test Location	+4	-4	+6	-6							Comments
1	ND	ND	ND	ND							
2	ND	ND	ND	ND							
3	A	A	A	A							
4	A	A	A	A							
5	A	A	A	A							
6	A	A	A	A							
7	A	A	A	A							
8	ND	ND	ND	ND							
9	ND	ND	ND	ND							
Air Discharge	Voltage kV 10 Discharge @ 1 PPS										
Test Location	+2	-2	+4	-4	+8	-8					Comments
1	ND	ND	ND	ND	A	A					
2	ND	ND	ND	ND	A	A					
3	A	A	A	A	A	A					
4	A	A	A	A	A	A					
5	A	A	A	A	A	A					
6	A	A	A	A	A	A					
7	A	A	A	A	A	A					
8	ND	ND	ND	ND	A	A					
9	ND	ND	ND	ND	A	A					
Indirect Discharge	Voltage kV 25 Discharge @ 1 PPS										
Test Location	+4	-4	+6	-6							Comments
VCP Front	A	A	A	A							
VCP Right	A	A	A	A							
VCP Left	A	A	A	A							
VCP Back	A	A	A	A							
Test Location	+4	-4	+6	-6							Comments
HCP Front	A	A	A	A							
HCP Right	A	A	A	A							
HCP Left	A	A	A	A							
HCP Back	A	A	A	A							

Additional Notes: A=criteria A, B=criteria B, C=criteria C

Note: Test points are according to customer requirements.

3.3.5 Test Point

Red arrow lines indicate the contact points, and blue arrow lines indicate the air points.

Figure-1. Test Point Assignments Discharge:

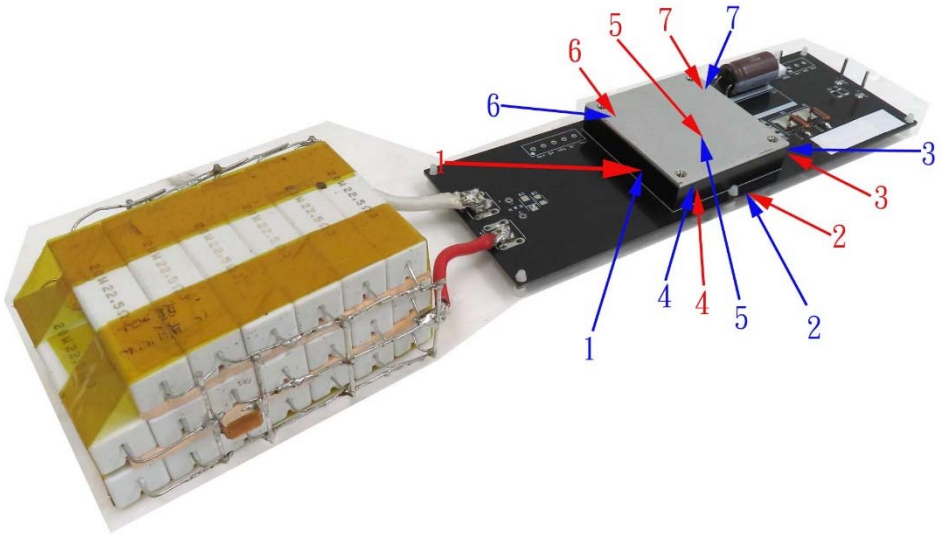
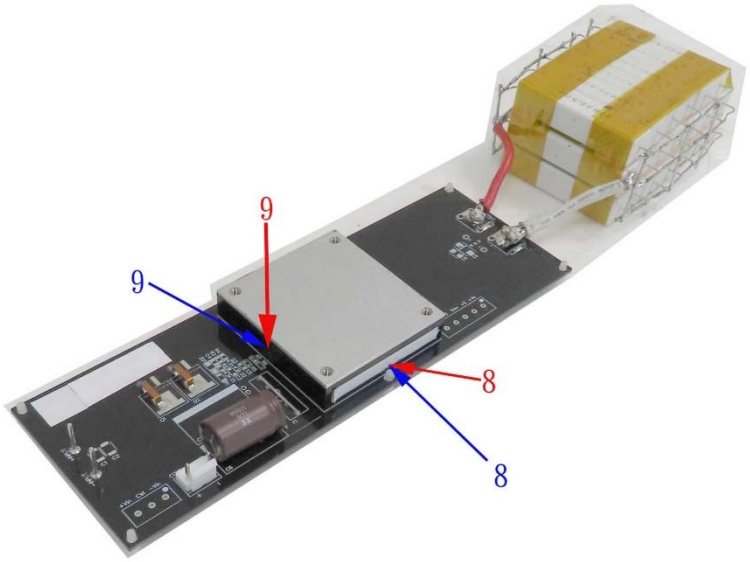
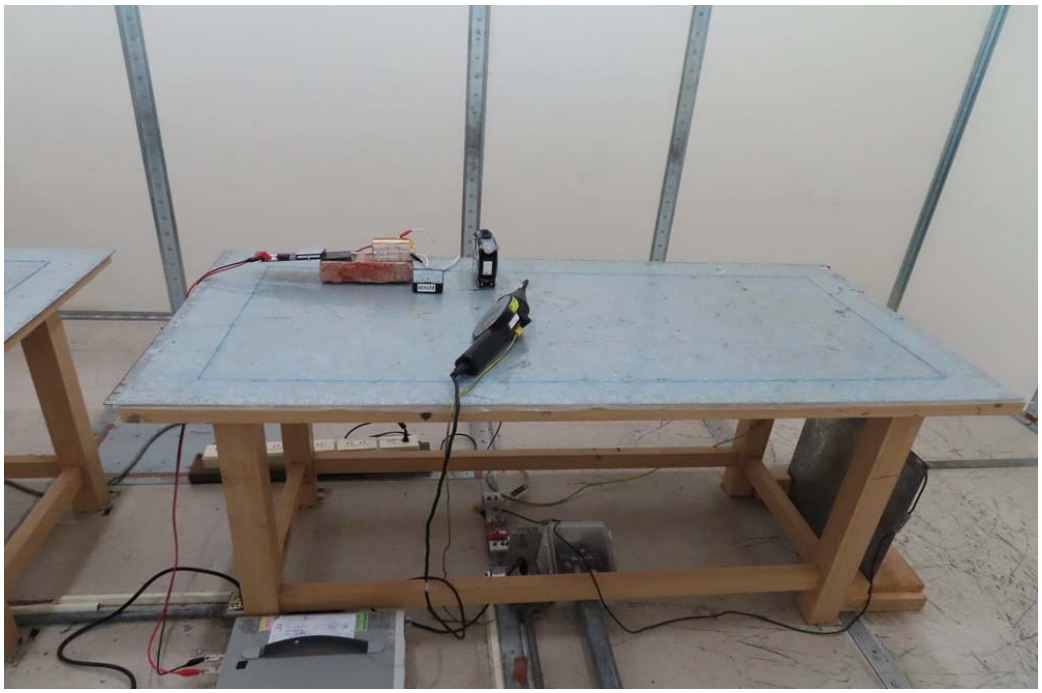


Figure-2. Test Point Assignments Discharge:



3.3.6 Test Setup Photo



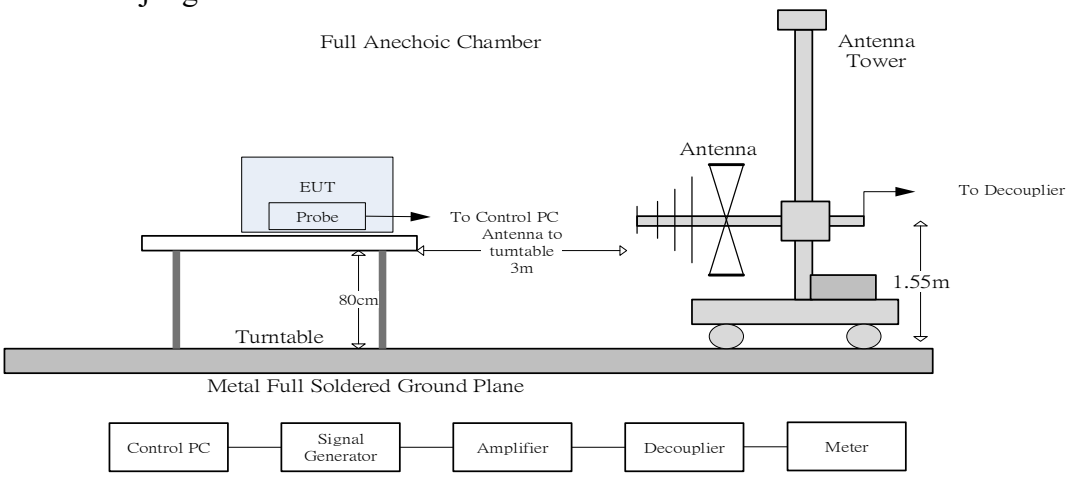
3.4 Radio-Frequency, Electromagnetic Field immunity

3.4.1 Test Specification

Port:	Enclosure
Basic Standard:	EN 61000-4-3 / IEC EN61000-4-3 / BS EN 61000-4-3 (details referred to Sec 1.2)
Frequency range/Test Level:	80 MHz to 1000 MHz: 20 V/m 1400 MHz to 2000 MHz: 10 V/m 2000 MHz to 2700 MHz: 5 V/m 5100 MHz to 6000 MHz: 3 V/m
Modulation:	AM 1KHz 80%
Frequency Step:	1% of last step frequency
Dwell time:	2s
Polarization:	Vertical and Horizontal
EUT Azimuth Angle	☒0° ☒90° ☒180° ☒270°
Criteria:	A
Test Procedure:	refer to ISL QA -T4-E-S8

3.4.2 Test Setup

The field sensor is placed at one calibration grid point to check the intensity of the established fields on both polarizations. EUT is adjusted to have each side of EUT face coincident with the calibration plane. A CCD camera and speakers are used to monitor the condition of EUT for the performance judgment.



3.4.3 Test Result

Performance of EUT complies with the given specification.

3.4.4 Test Data: Configuration 1

Basic Standard	EN 61000-4-3	Date
EUT Model Name	TEP 200-7213UIR-N	2021-06-29
		Engineer
Barometer Pressure	102.2kPa	SAWYER
Temperature	23℃	Equipment & Test Site
Humidity	55%	Chamber 15
Voltage/Freq.	72 Vdc	

A=criteria A, B=criteria B, C=criteria C

EUT Angle	Frequency		Dwell time	Modulation	Level (V/m)	Antenna Polarization	EUT Status	Comments
	Range (MHz)	Steps %						
0°(front)	80-1000	1	2s	80% @ 1kHz	20	Vertical	A	
90°(left)	80-1000	1	2s	80% @ 1kHz	20	Vertical	A	
180°(back)	80-1000	1	2s	80% @ 1kHz	20	Vertical	A	
270°(right)	80-1000	1	2s	80% @ 1kHz	20	Vertical	A	
0°(front)	80-1000	1	2s	80% @ 1kHz	20	Horizontal	A	
90°(left)	80-1000	1	2s	80% @ 1kHz	20	Horizontal	A	
180°(back)	80-1000	1	2s	80% @ 1kHz	20	Horizontal	A	
270°(right)	80-1000	1	2s	80% @ 1kHz	20	Horizontal	A	

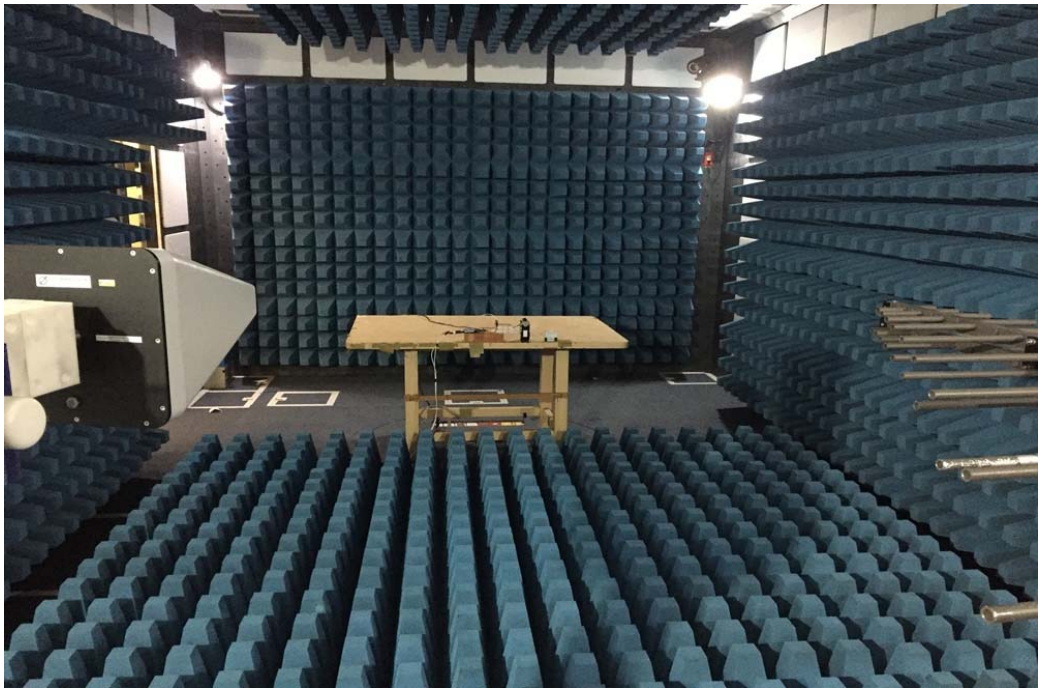
EUT Angle	Frequency		Dwell time	Modulation	Level (V/m)	Antenna Polarization	EUT Status	Comments
	Range (MHz)	Steps %						
0°(front)	1400-2000	1	2s	80% @ 1KHz	10	Vertical	A	
90°(left)	1400-2000	1	2s	80% @ 1KHz	10	Vertical	A	
180° (back)	1400-2000	1	2s	80% @ 1KHz	10	Vertical	A	
270° (right)	1400-2000	1	2s	80% @ 1KHz	10	Vertical	A	
0°(front)	1400-2000	1	2s	80% @ 1KHz	10	Horizontal	A	
90°(left)	1400-2000	1	2s	80% @ 1KHz	10	Horizontal	A	
180° (back)	1400-2000	1	2s	80% @ 1KHz	10	Horizontal	A	
270° (right)	1400-2000	1	2s	80% @ 1KHz	10	Horizontal	A	

EUT Angle	Frequency		Dwell time	Modulation	Level (V/m)	Antenna Polarization	EUT Status	Comments
	Range (MHz)	Steps %						
0°(front)	2000-2700	1	2s	80% @ 1KHz	5	Vertical	A	
90°(left)	2000-2700	1	2s	80% @ 1KHz	5	Vertical	A	
180°(back)	2000-2700	1	2s	80% @ 1KHz	5	Vertical	A	
270°(right)	2000-2700	1	2s	80% @ 1KHz	5	Vertical	A	
0°(front)	2000-2700	1	2s	80% @ 1KHz	5	Horizontal	A	
90°(left)	2000-2700	1	2s	80% @ 1KHz	5	Horizontal	A	
180°(back)	2000-2700	1	2s	80% @ 1KHz	5	Horizontal	A	
270°(right)	2000-2700	1	2s	80% @ 1KHz	5	Horizontal	A	

EUT Angle	Frequency		Dwell time	Modulation	Level (V/m)	Antenna Polarization	EUT Status	Comments
	Range (MHz)	Steps %						
0°(front)	5100-6000	1	2s	80% @ 1KHz	3	Vertical	A	
90°(left)	5100-6000	1	2s	80% @ 1KHz	3	Vertical	A	
180° (back)	5100-6000	1	2s	80% @ 1KHz	3	Vertical	A	
270° (right)	5100-6000	1	2s	80% @ 1KHz	3	Vertical	A	
0°(front)	5100-6000	1	2s	80% @ 1KHz	3	Horizontal	A	
90°(left)	5100-6000	1	2s	80% @ 1KHz	3	Horizontal	A	
180° (back)	5100-6000	1	2s	80% @ 1KHz	3	Horizontal	A	
270° (right)	5100-6000	1	2s	80% @ 1KHz	3	Horizontal	A	

Additional Notes: A=criteria A, B=criteria B, C=criteria C

3.4.5 Test Setup Photo



3.5 Electrical Fast transients/burst immunity

3.5.1 Test Specification

Basic Standard:	EN 61000-4-4 / IEC EN61000-4-4 / BS EN 61000-4-4 (details referred to Sec 1.2)
Signal & communication, process measurement & control ports Test Level:	+/- 2 kV
Battery referenced ports (except at the output of energy sources) Auxiliary a.c. power input ports (rated voltage ≤ 400 V rms)	+/- 2 kV
Rise Time:	5ns
Hold Time:	50ns
Repetition Frequency:	5KHz
Criteria:	A
Test Procedure:	refer to ISL QA -T4-E-S9

Test Procedure

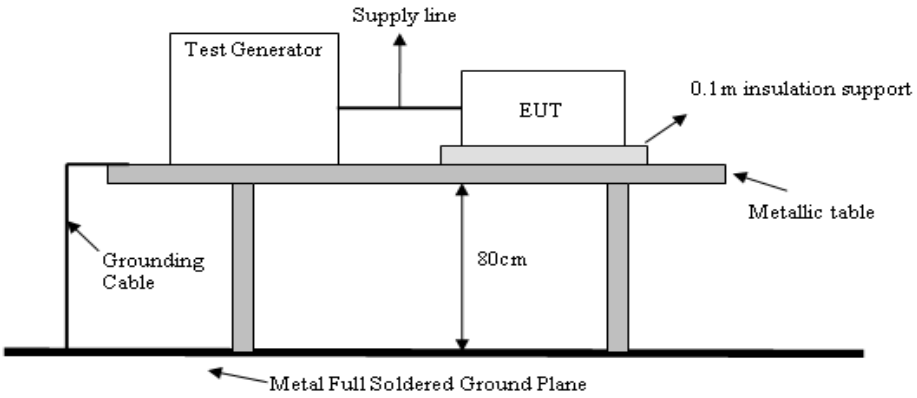
The EUT was setup on a nonconductive table 0.1 m above a reference ground plane.

Test Points	Polarity	Result	Comment
Line	+	N	60 sec
	-	N	60 sec
Neutral	+	N	60 sec
	-	N	60 sec
Line to Neutral	+	N	60 sec
	-	N	60 sec

Note: 'N' means normal, the EUT function is correct during the test.

3.5.2 Test Setup

EUT is at least 50cm from the conductive structure.

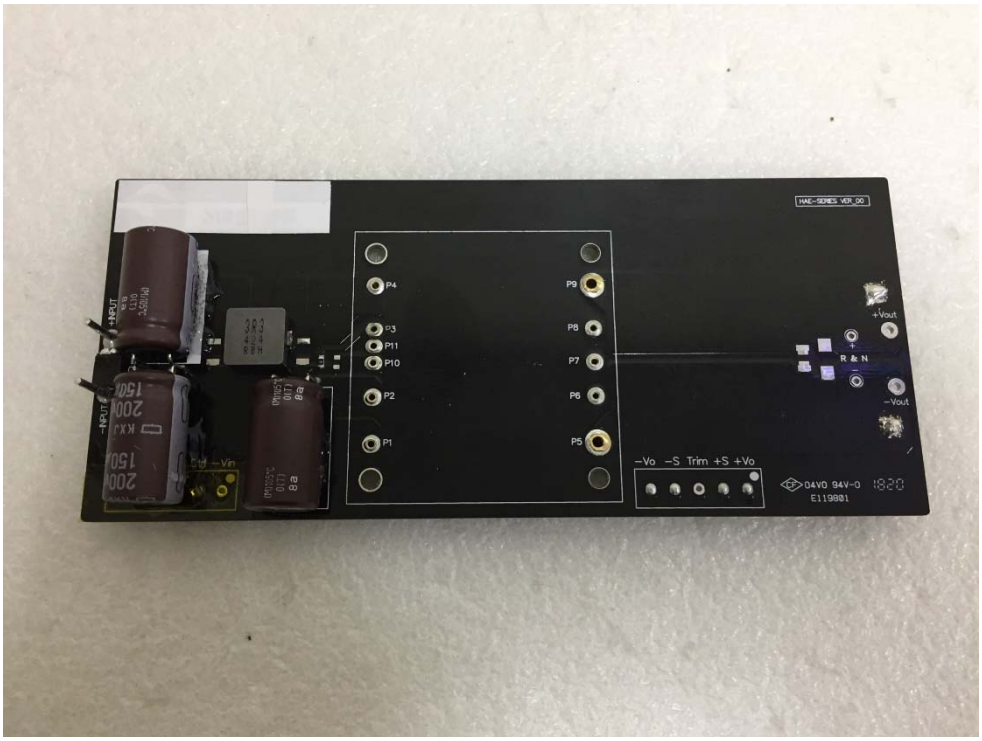


3.5.3 Test Result

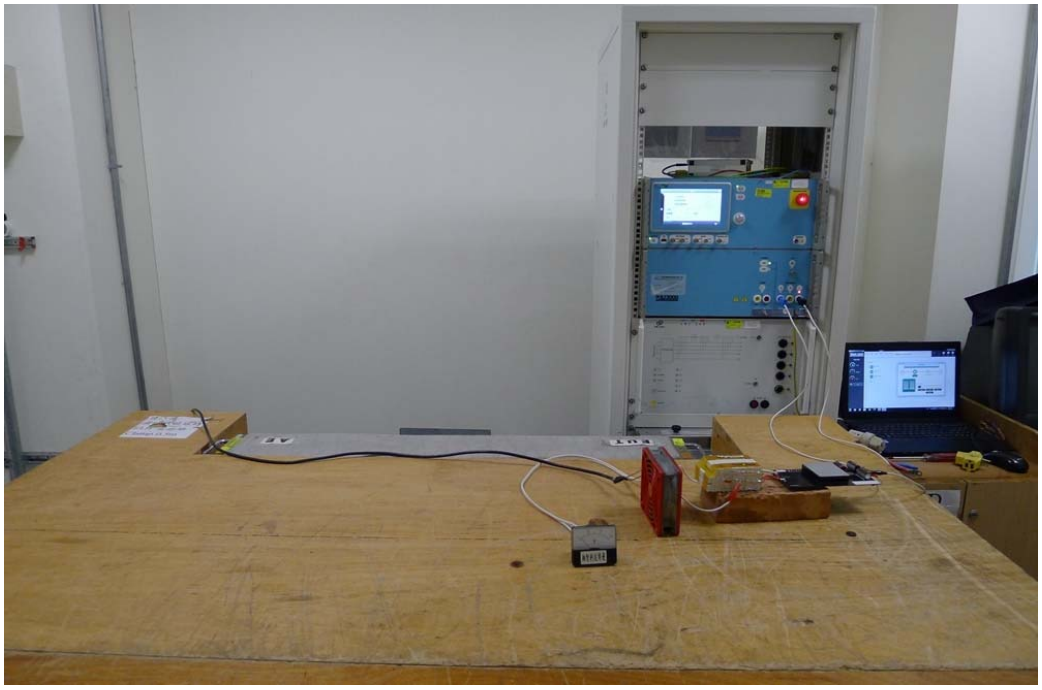
Performance of EUT complies with the given specification.

3.5.4 Test Data: Configuration 1

Basic Standard	EN 61000-4-4					Date	
EUT Model Name	TEP 200-7213UIR-N					2021-06-21	
						Engineer	
Barometer Pressure	102.3kPa					SAWYER	
Temperature	24℃					Equipment & Test Site	
Humidity	52%					EMC-PARTNER (Model: IMU3000)	
Voltage/Freq.	72 Vdc						
A=criteria A, B=criteria B, C=criteria C							
AC Power Port: ☐	DC Power Port: ☑		LAN Port: ☐			Telephone Port: ☐	
DC Power Port							
Line Under Test	Voltage Level	Severity Level	Pulse Polarity	Burst Repetition Rate	Test Duration	EUT Status	Comments
Line	2.0kV	3	+	300ms / 5.0kHz	1 Minutes	A	
Line	2.0kV	3	-	300ms / 5.0kHz	1 Minutes	A	
Neutral	2.0kV	3	+	300ms / 5.0kHz	1 Minutes	A	
Neutral	2.0kV	3	-	300ms / 5.0kHz	1 Minutes	A	
Line- Neutral	2.0kV	3	+	300ms / 5.0kHz	1 Minutes	A	
Line- Neutral	2.0kV	3	-	300ms / 5.0kHz	1 Minutes	A	
Additional Notes: A=criteria A, B=criteria B, C=criteria C							
NOTE: For the countermeasure components, please refer to Solution:" For Electrical Fast transient & Surge Immunity test requirements"							



3.5.5 Test Setup Photo

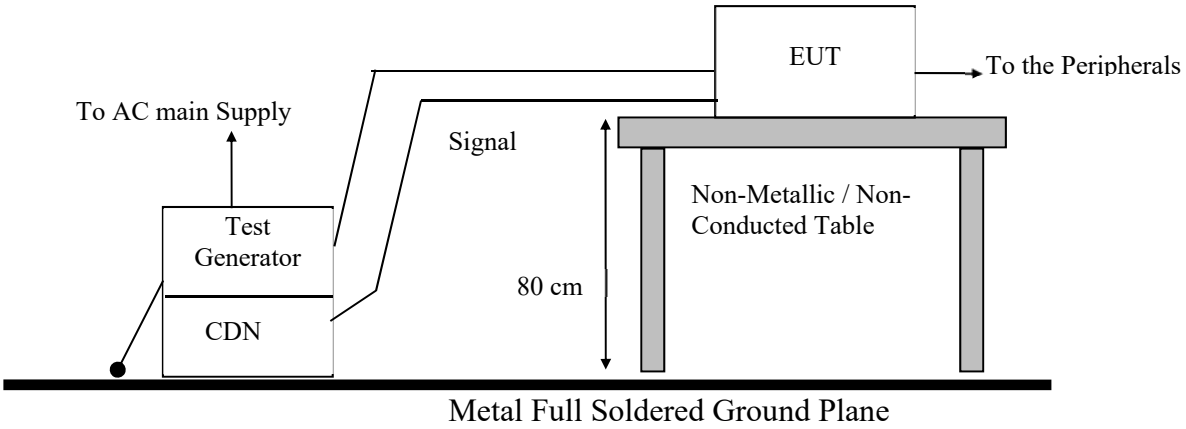


3.6 Surge Immunity

3.6.1 Test Specification

Basic Standard:	EN 61000-4-5 / IEC EN61000-4-5 / BS EN 61000-4-5 (details referred to Sec 1.2)
Battery referenced ports (except at the output of energy sources) Auxiliary a.c. power input ports (rated voltage ≤ 400 V rms)	Line to Line: 42 Ω, 0.5 μF +/- 0.5 kV, +/- 1 kV, +/- 2 kV
Rise Time:	1.2us
Hold Time:	50us
Repetition Rate:	60 seconds, 5 time/each condition
Angle:	☐0° ☐90° ☐180° ☐270°
Criteria:	B
Test Procedure:	refer to ISL QA -T4-E-S10

3.6.2 Test Setup



3.6.3 Test Result

Performance of EUT complies with the given specification.

3.6.4 Test Data: Configuration 1

Basic Standard	EN 61000-4-5			Date	
EUT Model Name	TEP 200-7213UIR-N			2021-06-21	
				Engineer	
Barometer Pressure	102.3kPa			SAWYER	
Temperature	24℃			Equipment & Test Site	
Humidity	52%			EMC-PARTNER (Model: IMU3000)	
Voltage/Freq.	72 Vdc				
A=criteria A, B=criteria B, C=criteria C					
AC Power Port: ☐	DC Power Port: ☑	LAN Port: ☐	Telephone Port: ☐		

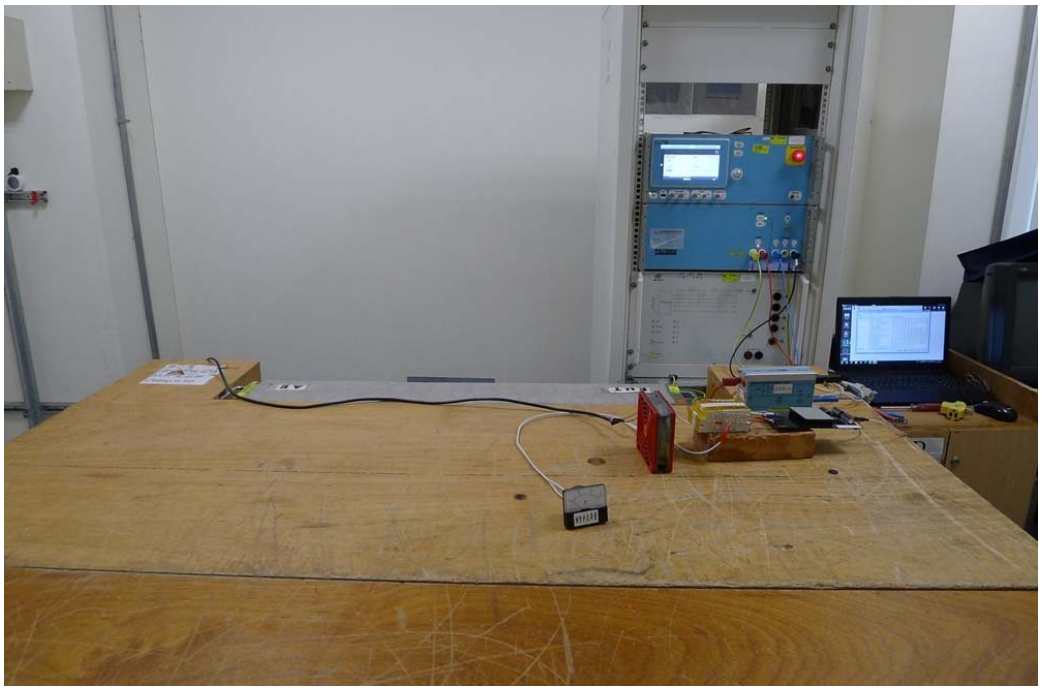
DC Power Port

Line Under Test	Voltage	Level	Impedance	Repetition Rate	Cycle	Pulse Position	EUT Status	Comments
Line-Neutral	+0.5kV	2	42Ω	60 sec	5		A	
Line-Neutral	−0.5kV	2	42Ω	60 sec	5		A	
Line- Neutral	+1.0kV	3	42Ω	60 sec	5		A	
Line- Neutral	−1.0kV	3	42Ω	60 sec	5		A	
Line- Neutral	+2.0kV	3	42Ω	60 sec	5		A	
Line- Neutral	−2.0kV	3	42Ω	60 sec	5		A	

Additional Notes: A=criteria A, B=criteria B, C=criteria C

NOTE:
For the countermeasure components, please refer to Solution:" For Electrical Fast transient & Surge Immunity test requirements"

3.6.5 Test Setup Photo

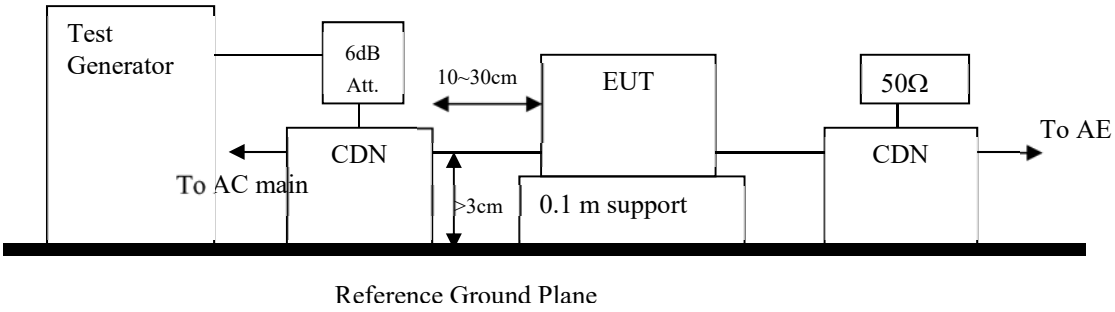


3.7 Immunity to Conductive Disturbance

3.7.1 Test Specification

Basic Standard:	EN 61000-4-6 / IEC EN61000-4-6 / BS EN 61000-4-6 (details referred to Sec 1.2)
Battery referenced ports (except at the output of energy sources) Auxiliary a.c. power input ports (rated voltage ≤ 400 V rms)Test Level:	10 V
Signal & communication, process measurement & control ports Test Level:	10 V
Modulation:	AM 1KHz 80%
Frequency range:	0.15 MHz - 80MHz
Frequency Step:	1% of last Frequency
Dwell time:	2s
Criteria:	A
CDN Type:	CDN M2+M3
Test Procedure:	refer to ISL QA -T4-E-S11

3.7.2 Test Setup



Reference Ground Plane

3.7.3 Test Result

Performance of EUT complies with the given specification.

3.7.4 Test Data: Configuration 1

Basic Standard	EN 61000-4-6	Date
EUT Model Name	TEP 200-7213UIR-N	2021-06-29
		Engineer
Barometer Pressure	102.2kPa	SAWYER
Temperature	24℃	Equipment & Test Site
Humidity	57%	FRANKONIA (Model: CIT-10/75)
Voltage/Freq.	72 Vdc	

A=criteria A, B=criteria B, C=criteria C

DC Power Port

Line Under Test	Frequency		Level	Modulation	Dwell time	EUT Status	Comments
	Range (MHz)	Steps %					
DC Power Port	0.15 to 80	1	10V	80% @ 1kHz	2s	A	

Additional Notes: A=criteria A, B=criteria B, C=criteria C

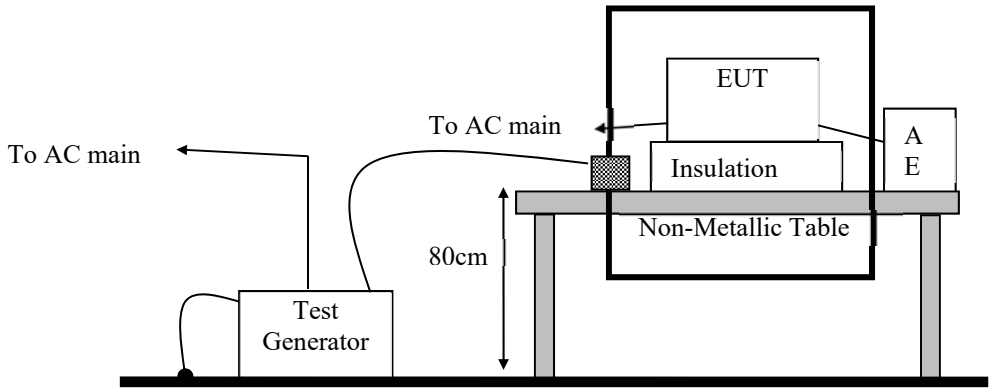
3.7.5 Test Setup Photo

3.8 Power Frequency Magnetic Field immunity

3.8.1 Test Specification

Port:	Enclosure
Basic Standard:	EN 61000-4-8/ IEC 61000-4-8 / BS EN 61000-4-8 (details referred to Sec 1.2)
D.C. systems Test Level:	100A/m(continuous),1000A/m(1s)
Polarization:	X, Y, Z
Criteria:	A
Test Procedure:	refer to ISL QA -T4-E-S12

3.8.2 Test Setup



3.8.3 Test Result

Performance of EUT complies with the given specification.

3.8.4 Test Data: Configuration 1

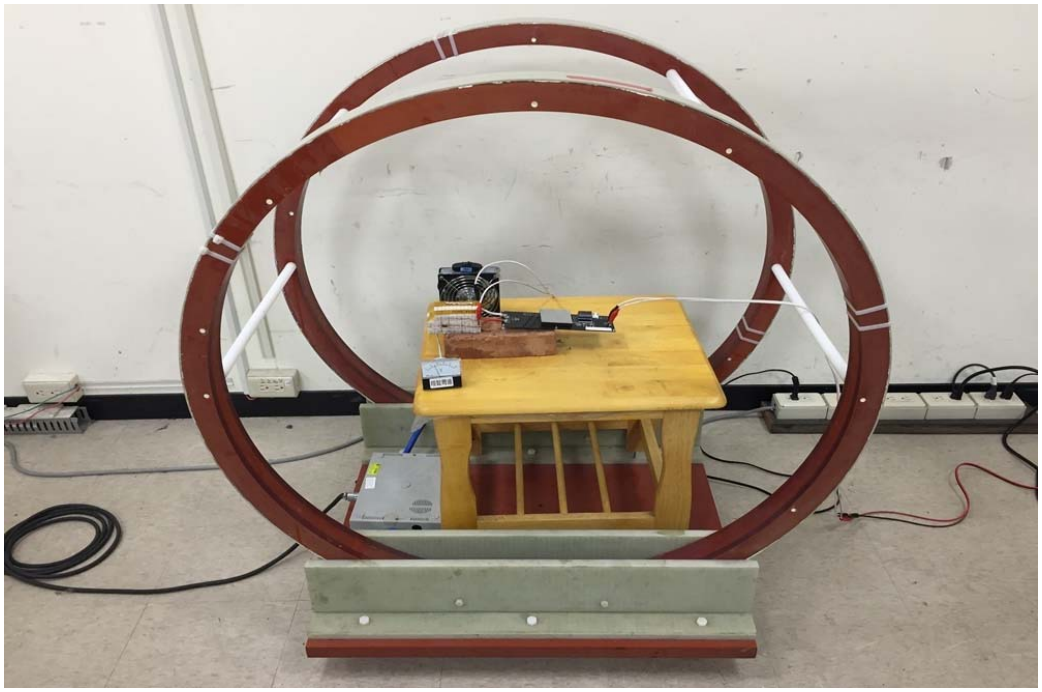
Basic Standard	EN 61000-4-8	Date
EUT Model Name	TEP 200-7213UIR-N	2021-06-29
		Engineer
Barometer Pressure	102.3kPa	SAWYER
Temperature	24℃	Equipment & Test Site
Humidity	55%	Magnetic Field Immunity Loop Brand: Pic Model:PMF1000 & Magnetic Field Test AC Power Source Brand: Pic Model: AC Power Source
Voltage/Freq.	72Vdc	

A=criteria A, B=criteria B, C=criteria C

Antenna Polarization	Frequency (Hz)	Test Level	Test Duration	EUT Status	Comment
X	0	100 A/m	1 Minutes	A	
Y	0	100 A/m	1 Minutes	A	
Z	0	100 A/m	1 Minutes	A	
X	0	1000 A/m	1 Second	A	
Y	0	1000 A/m	1 Second	A	
Z	0	1000 A/m	1 Second	A	

Additional Notes: A=criteria A, B=criteria B, C=criteria C

3.8.5 Test Setup Photo



4. Environmental Tests

4.1 Low temperature start-up test

4.1.1 Test Ambience

Temperature:21℃ ± 2℃
Humidity: 53% ± 6%

4.1.2 Test Procedure

Test Procedures were referred to EN 50155 sub-clause 13.4.4

4.1.3 Test Condition

Table 1 – Operating temperature classes

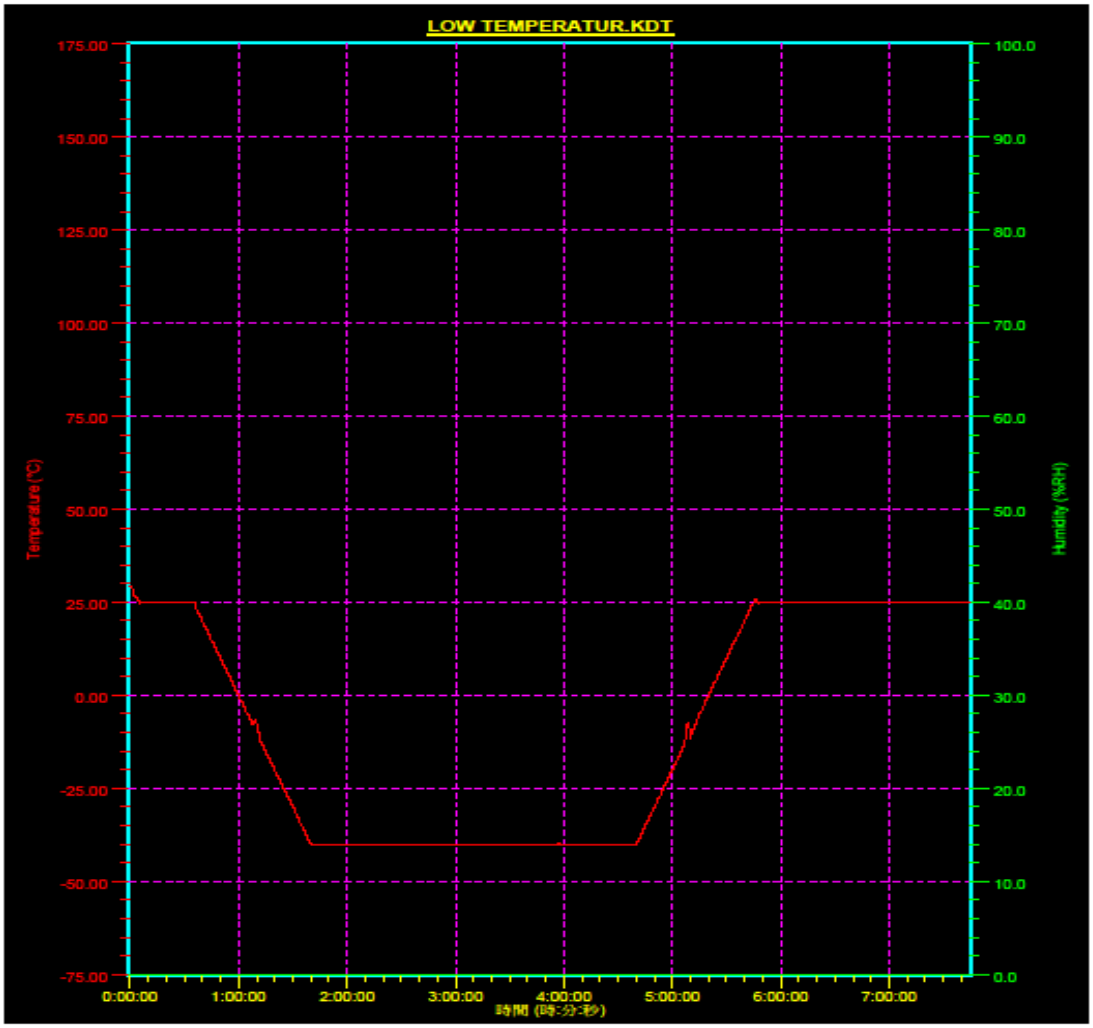
Class	Equipment operating temperature range (°C)	Test Condition
OT1	-25 to +55	
OT2	-40 to +55	V
OT3	-25 to +70	
OT4	-40 to +70	
OT5	-25 to +85	
OT6	-40 to +85	

4.1.4 Test Result

A. Photo of test Setup was shown in 4.1.5
B. Testing data were shown as below
C. Test specimen was visually inspected after test. No physical damage occurred.
D. The function of specimen was normal during and after the cooling test.
E. According to test result, the specimen passed the EN 50155 sub-clause 13.4.4 Low temperature start-up test.

Low temperature start-up test Record

KSON DAT Viewer SE Report



檔案名稱: E:\Low temperatur.KDT
時間範圍: 06:00:01 08/11/2021 - 13:44:55 08/11/2021
時間範圍: 0:0:0 - 7:44:54

Y軸:
Temperature(°C) -75.000 ~ 175.000
Humidity(%RH) 0.00 ~ 100.00

曲線:
1. Temperature(°C)
2. Humidity(%RH)

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4.1.5 Test Setup Photo

4.2 Dry Heat Test

4.2.1 Test Ambience

Temperature:21℃ ± 2℃
Humidity: 53% ± 6%

4.2.2 Test Procedure

Test Procedures were referred to EN 50155 sub-clause 13.4.5

4.2.3 Test Condition

Table 1 – Operating temperature classes

Class	Equipment operating temperature range (°C)	Test Condition
OT1	-25 to +55	
OT2	-40 to +55	V
OT3	-25 to +70	
OT4	-40 to +70	
OT5	-25 to +85	
OT6	-40 to +85	

Table 2 –Switch-on extended Operating temperature classes

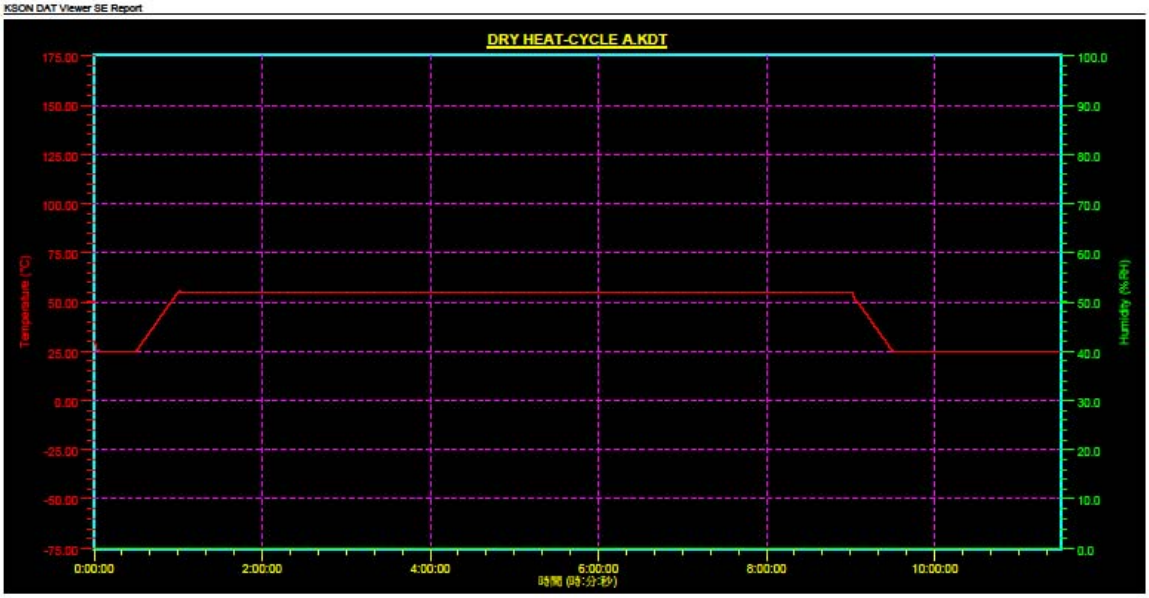
Class	Switch-on extended Operating temperature (duration: 10 min)	Thermal test cycle See 13.4.5	Test Condition
ST0	No switch-on extended operating temperature	Test cycle A	
ST1	OTx + 15 °C	Test cycle B	V
ST2	OTx + 15 °C	Test cycle C	

4.2.4 Test Result

A. Photo of test Setup was shown in 4.1.5.
B. The testing data were shown in Figure 1.
C. The testing data were shown in Figure 2.
D. Test specimen was visually inspected after test. No physical damage occurred.
E. The function of specimen was normal during and after the Dry heat test.
F. According to test result, the specimen passed the EN 50155 sub-clause 13.4.5 Dry heat test.

Dry Heat test Record (Test cycle A)

KSON DAT Viewer SE Report



檔案名稱: E:\dry heat-cycle A.KDT
時間範圍: 06:00:01 08/10/2021 - 17:30:01 08/10/2021
時間範圍: 0:0:0 - 11:30:0

Y軸:
Temperature(°C) -75.000 ~ 175.000
Humidity(%RH) 0.00 ~ 100.00

曲線:
1. Temperature(°C)
2. Humidity(%RH)

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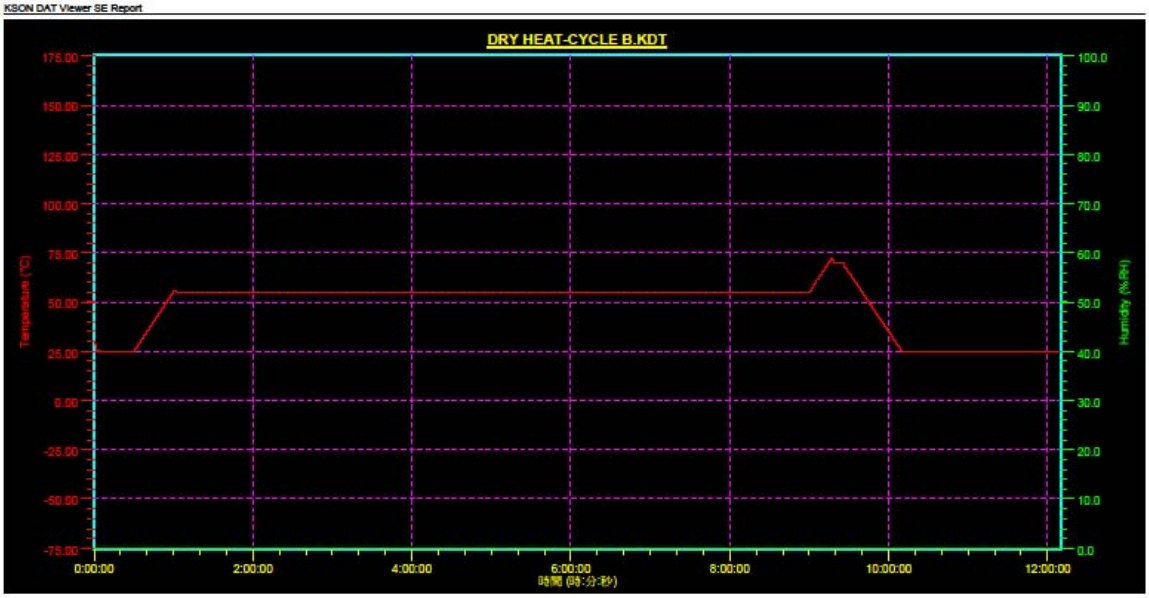
Dry Heat test Record (Test cycle B)

KSON DAT Viewer SE Report



檔案名稱: E:\Dry heat-cycle B.KDT
時間範圍: 06:30:01 08/12/2021 - 18:39:55 08/12/2021
時間範圍: 0:0:0 - 12:9:54

Y軸:
Temperature(°C) -75.000 ~ 175.000
Humidity(%RH) 0.00 ~ 100.00

曲線:
1. Temperature(°C)
2. Humidity(%RH)

09:08:18 Tuesday, August 17, 2021 Page 1/1

4.2.5 Test Setup Photo

4.3 Damp Heat Test

4.3.1 Test Ambience

Temperature: 21℃ ± 2℃
Humidity: 53% ± 6%

4.3.2 Test Procedure

Test Procedures were referred to EN 50155 sub-clause 13.4.7

4.3.3 Test Condition

Temperature / Humidity:55℃ and 25℃, 95%±5%RH without condensation, 48 hours.
Performance Check: The performance check was carried out before and after the Damp Heat Test.

4.3.4 Test Result

A. Photo of test Setup was shown in 4.1.5.
B. The testing data were shown as below.
C. Test specimen was visually inspected after test. No physical damage occurred.
D. The function of specimen was normal during and after the Damp heat test.
E. According to test result, the specimen passed the EN 50155 ch.13.4.7 Damp heat test.

Damp Heat Test Record

KSON DAT Viewer SE Report

檔案名稱: E:\Cyclic damp heat test.KDT
時間範圍: 05:00:01 08/14/2021 - 10:39:55 08/16/2021
時間範圍: 0:0:0 - 53:39:54

Y軸:
Temperature(°C) -75.000 ~ 175.000
Humidity(%RH) 0.00 ~ 100.00

曲線:
1. Temperature(°C)
2. Humidity(%RH)

09:06:47 Tuesday, August 17, 2021 Page 1/1

Date : 2021/08/09	Temperature :22.3 ℃	Engineer : Jimmy Wen
EUT Model Name : TEP 200-7213UIR-N	Humidity : 58.6 %	Equipment: N-396T, THS-B4T-150, TH110-POSE,SE 7452
	Barometer Pressure: 99.2 kPa	Standard: EN 50155 insulation test

Insulation Test Requirement after first run:

1.Insulation measurement Test :

The insulation resistance test shall be carried out at 500 Vdc and the values recorded.
The test shall then be repeated after the voltage withstand test.
There shall be no fundamental deterioration from the initial measurement.

Test item	Test Time	Insulation measurement test		Comments
		before withstand	after withstand	
Primary side to secondary side	1 min	50GΩ	50GΩ	Pass

2.Voltage Withstand test

500Vac or 750Vdc for nominal battery voltages below 72 Vdc (or 50 Vac).
1000Vac or 1500Vdc for nominal battery voltage from 72Vdc up to 125Vdc, (or from 50 to 90 Vac), and
1500Vac or 2200Vdc for nominal battery voltage above 125Vdc and up to 315Vdc, (or from 90 to 225 Vac).
Neither disruptive discharge nor flashover shall occur

Test item	Test Voltage	Test Time	Result	Comments
Primary side to secondary side	1000Vac	1 min	0.382mA	Pass

Date : 2021/08/09	Temperature :22.3 ℃	Engineer : Jimmy Wen
EUT Model Name : TEP 200-7213UIR-N	Humidity : 58.6 %	Equipment: N-396T, THS-B4T-150, TH110-POSE,SE 7452
	Barometer Pressure: 99.2 kPa	Standard: EN 50155 insulation test

Insulation Test Requirement after second run:

1.Insulation measurement Test :

The insulation resistance test shall be carried out at 500 Vdc and the values recorded.
The test shall then be repeated after the voltage withstand test.
There shall be no fundamental deterioration from the initial measurement.

Test item	Test Time	Insulation measurement test		Comments
		before withstand	after withstand	
Primary side to secondary side	1 min	50GΩ	50GΩ	Pass

2.Voltage Withstand test

500Vac or 750Vdc for nominal battery voltages below 72 Vdc (or 50 Vac).
1000Vac or 1500Vdc for nominal battery voltage from 72Vdc up to 125Vdc, (or from 50 to 90 Vac), and
1500Vac or 2200Vdc for nominal battery voltage above 125Vdc and up to 315Vdc, (or from 90 to 225 Vac).
Neither disruptive discharge nor flashover shall occur

Test item	Test Voltage	Test Time	Result	Comments
Primary side to secondary side	1000Vac	1 min	0.322mA	Pass

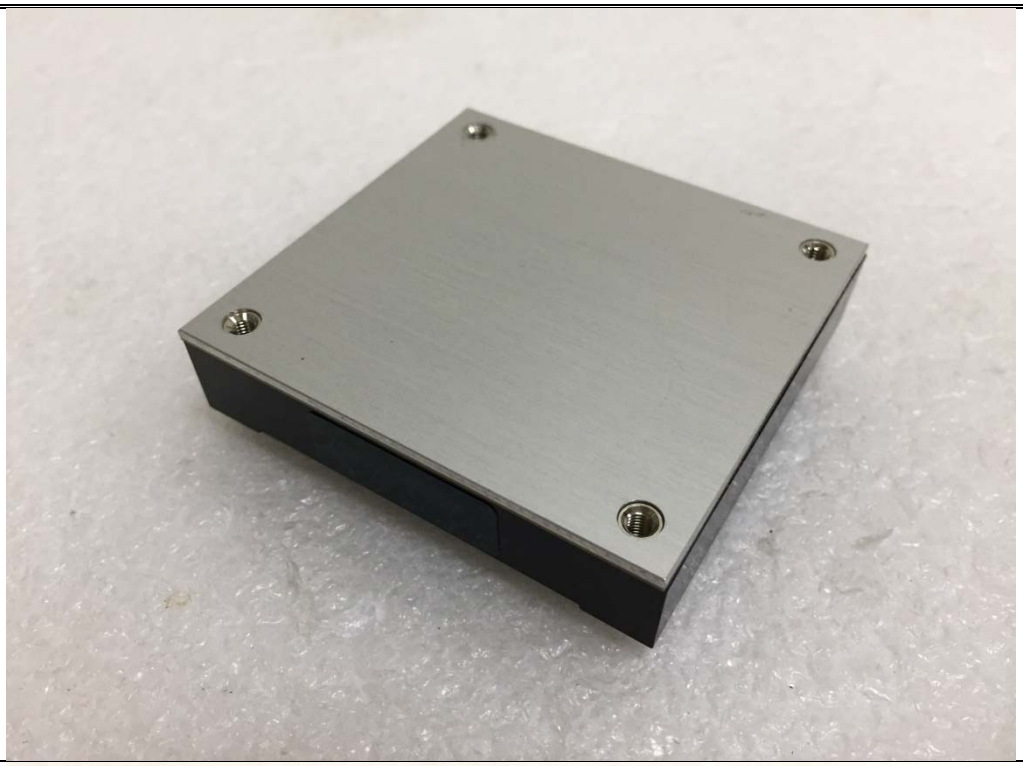
Date : 2021/8/9	Temperature :24 ℃	Engineer : SAWYER
EUT Model Name : TEP 200-7213UIR-N	Humidity : 58 %	Barometer Pressure: 99.2 kPa
		Standard: EN 50155
Voltage/Freq: 72Vdc		

Visual inspection requirement:

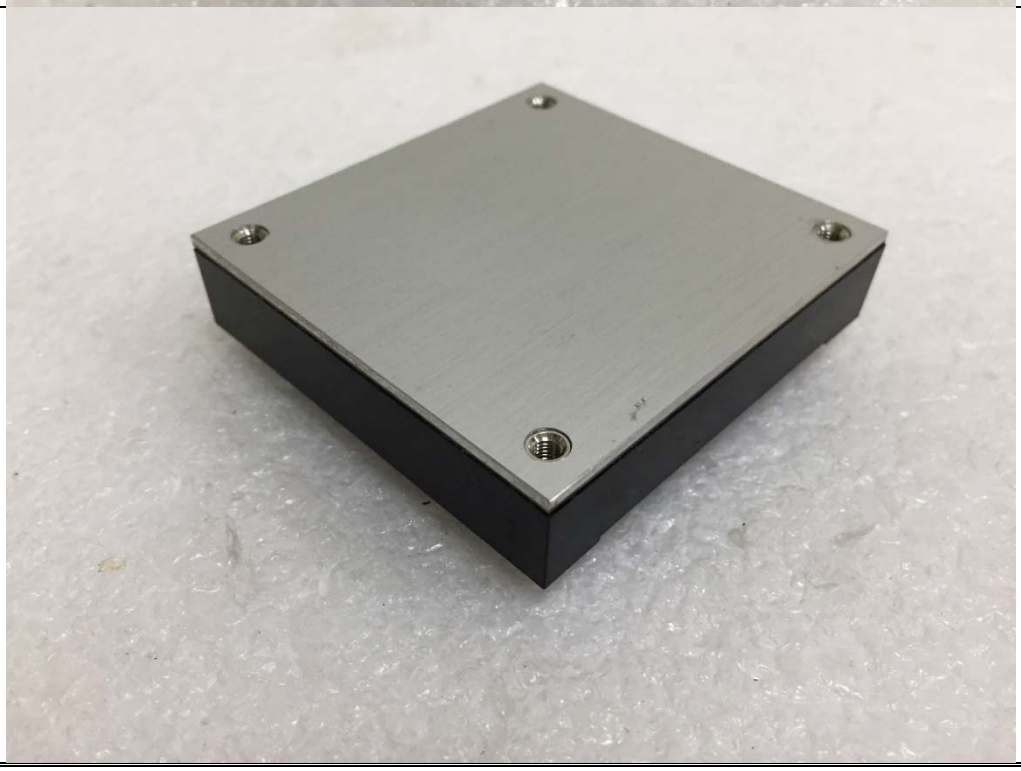
The visual inspection shall be carried out to ensure that the equipment is of sound construction and, so far as can be ascertained, meets its specified requirements.
A visual inspection shall also be carried out after a type test has been performed to check whether any damage or deterioration has occurred resulting from the tests.

Inspection item	Result
EUT outside	OK
EUT function	OK

After test：




-Vin
BUS
UVLO
Pulse Out
Ctrl
+Vin
-Vo
-Sense
Trim
+Sense
+Vo



4.4 Functional random Vibration Test

4.4.1 Test Specification and / or standard:

EN 61373:2010

4.4.2 Testing Equipment:

Vibration & Shock Environmental Equipment KD-9363EM-1000F2K-50N250
Max. force：1000 kgf-peak / 250 kgw Loading
Max. displacement：50 mm p-p
Max. acceleration：55 g
Frequency range：5 Hz to 2000 Hz
Calibrate trace code：VP-210317-1

4.4.3 Test Condition and procedure:

Test Condition:

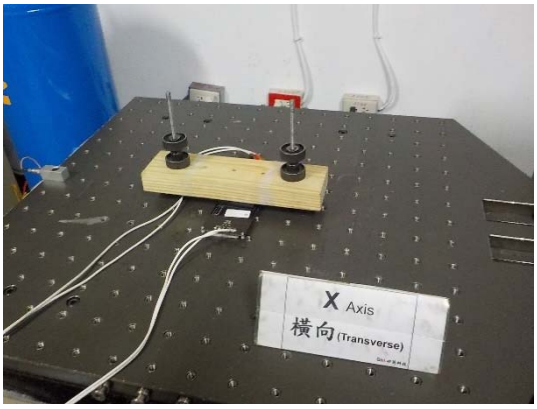
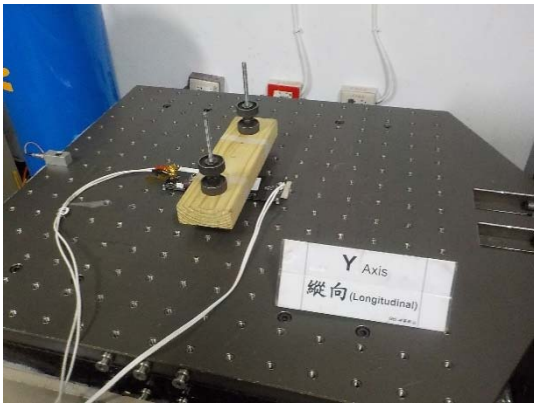
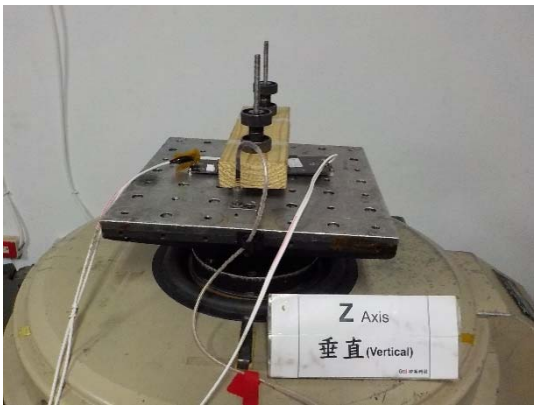
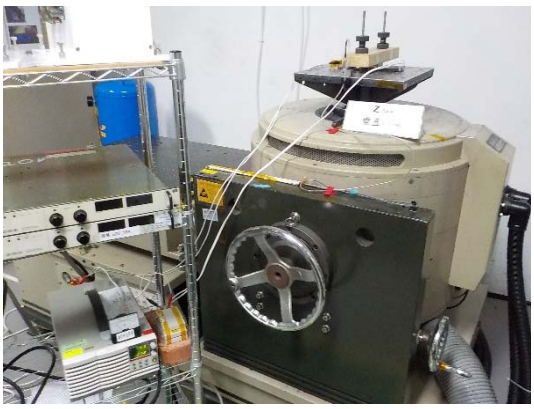
	Category	Orientation	RMS m/s^2
☐	1 Class A Body mounted	Vertical Transverse Longitudinal	0.75 0.37 0.5
☒	1 Class B Body mounted	Vertical Transverse Longitudinal	1.01 0.45 0.7
☐	2 Bogie mounted	Vertical Transverse Longitudinal	5.4 4.7 2.5
☐	3 Axle mounted	Vertical Transverse Longitudinal	38.0 34.0 17.0

Test Procedure:
A. Check out samples.
B. Place the test samples on the vibration table in its normal operating orientation and configuration.
C. Set test conditions and start to test.
D. Finish testing, check out samples and prepare final report.

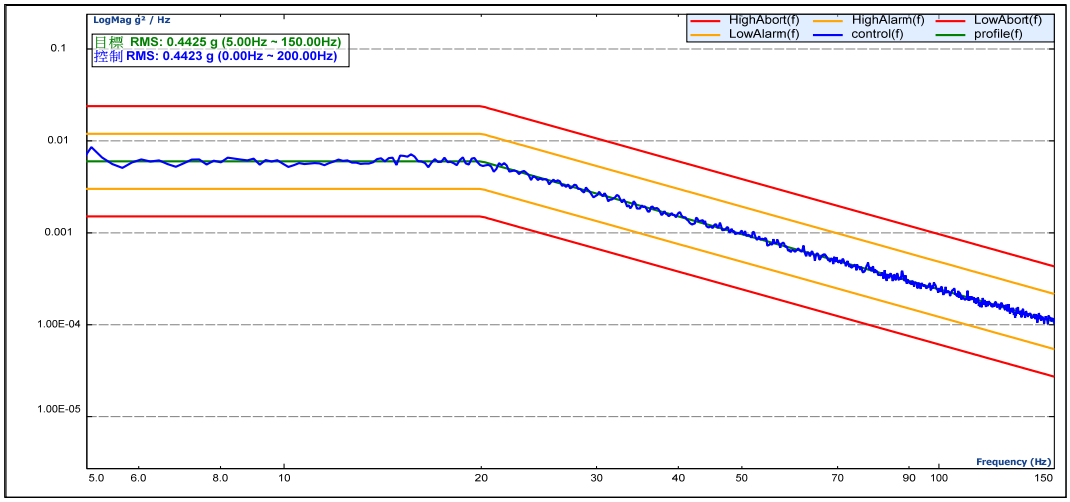
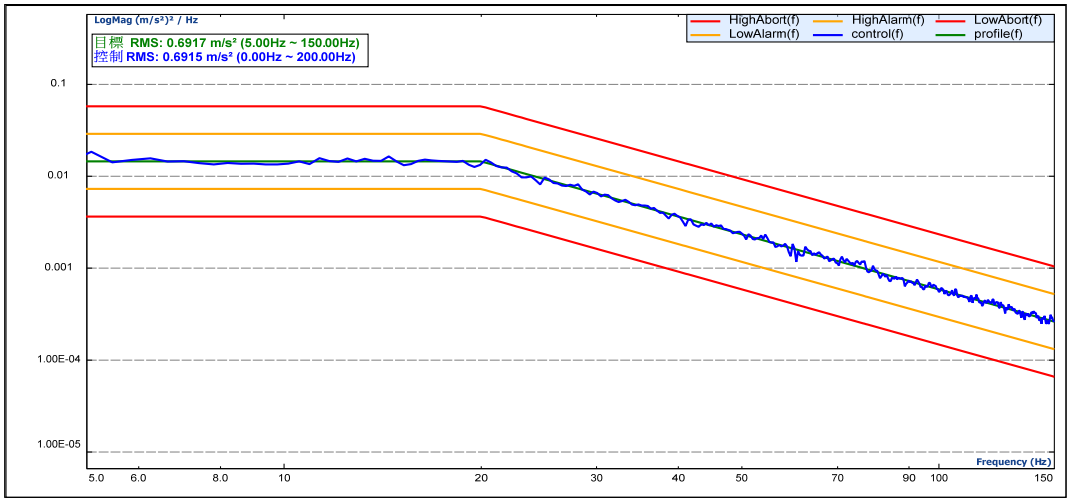
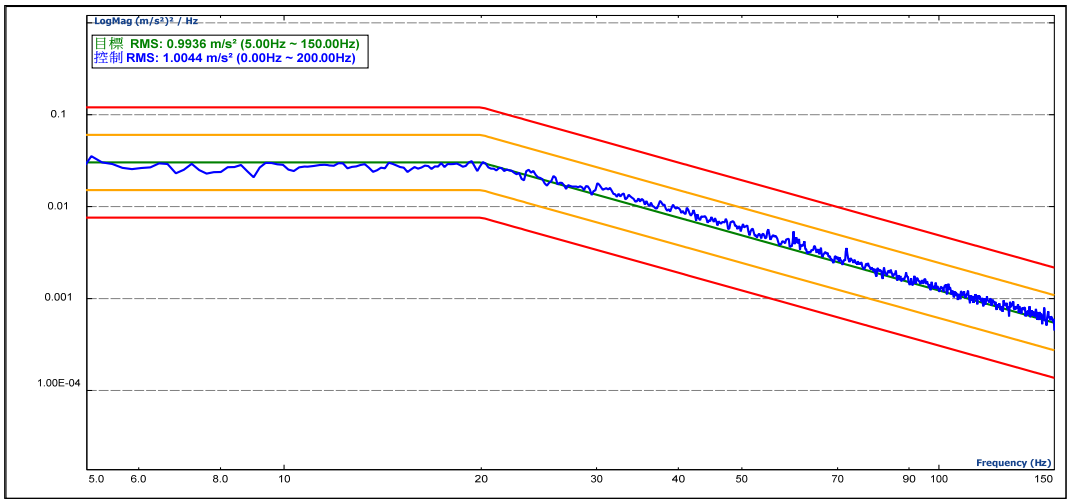
4.4.4 Test Result

Inspection item	Result
EUT	Pass

4.4.5 Test Setup Photo

Transverse		
Longitudinal		
Vertical		

4.4.6 Test Profile:

Transverse	
Longitudinal	
Vertical	

4.5 Simulated long-life testing at increased Random Vibration Test

4.5.1 Test Specification and/or standard:

EN 61373:2010

4.5.2 Testing Equipment:

Vibration & Shock Environmental Equipment KD-9363EM-1000F2K-50N250
Max. force：1000 kgf-peak / 250 kgw Loading
Max. displacement：50 mm p-p
Max. acceleration：55 g
Frequency range：5 Hz to 2000 Hz
Calibrate trace code：VP-210317-1

4.5.3 Test Condition and procedure:

Test Condition:

	Category	Orientation	RMS 5 h test period m/s^2
☐	1 Class A Body mounted	Vertical Transverse Longitudinal	4.25 2.09 2.83
☒	1 Class B Body mounted	Vertical Transverse Longitudinal	5.72 2.55 3.96
☐	2 Bogie mounted	Vertical Transverse Longitudinal	30.6 26.6 14.2
☐	3 Axle mounted	Vertical Transverse Longitudinal	144 129 64.3

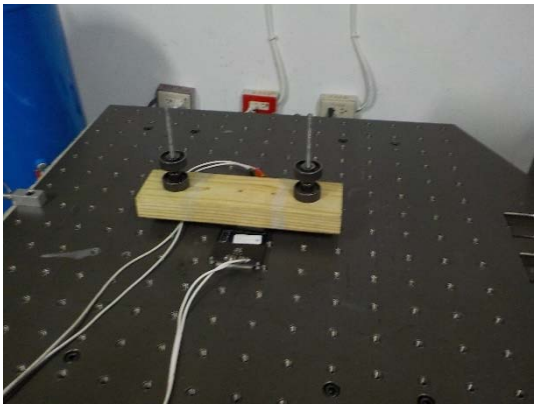
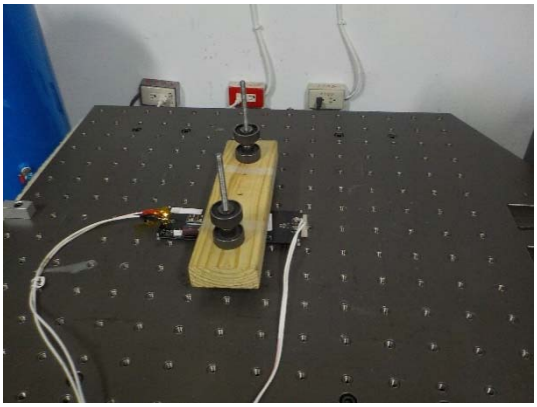
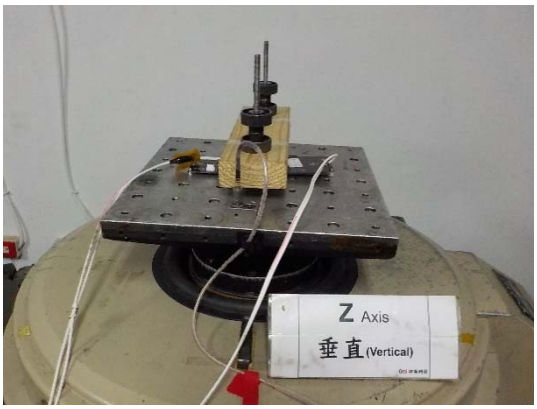
Test Procedure:

A. Check out samples.
B. Place the test samples on the vibration table in its normal operating orientation and configuration.
C. Set test conditions and start to test.
D. Finish testing, check out samples and prepare final report.

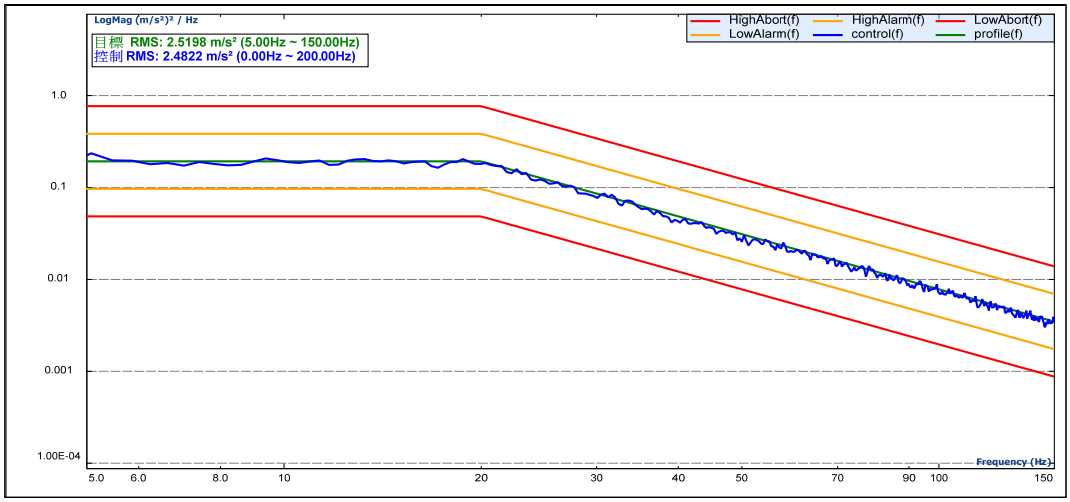
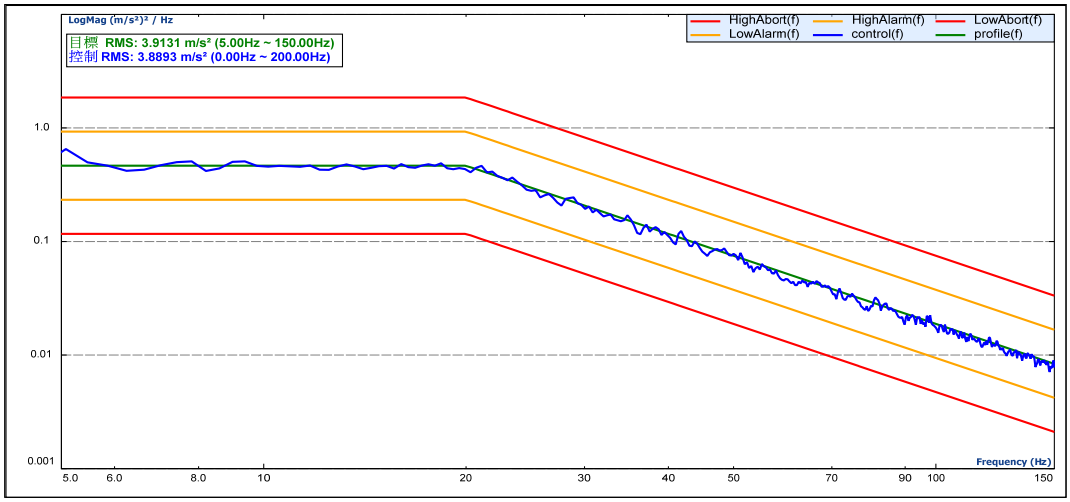
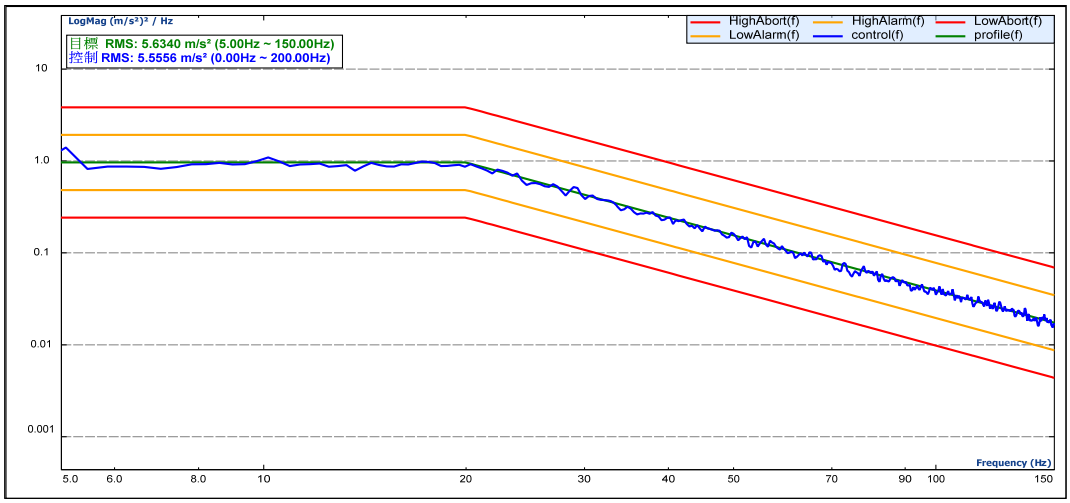
4.5.4 Test Result

Inspection item	Result
EUT	Pass

4.5.5 Test Setup Photo

Transverse	
Longitudinal	
Vertical	

4.5.6 Test Profile:

Transverse	
Longitudinal	
Vertical	

4.6 Shock Test

4.6.1 Test Specification and/or standard:

EN 61373:2010

4.6.2 Testing Equipment:

Vibration & Shock Environmental Equipment KD-9363EM-1000F2K-50N250
Max. force：1000 kgf-peak / 250 kgw Loading
Max. displacement：50 mm p-p
Max. acceleration：55 g
Frequency range：5 Hz to 2000 Hz
Calibrate trace code：VP-210317-1

4.6.3 Test Condition and procedure:

Test Condition:

	Category	Orientation	Peak acceleration A m/s^2	Nominal duration D ms
☒	1 Class A and Class B Body mounted	Vertical Transverse Longitudinal	30 30 50	30 30 30
☐	2 Bogie mounted	Vertical Transverse Longitudinal	300	18
☐	3 Axle mounted	Vertical Transverse Longitudinal	1000	6

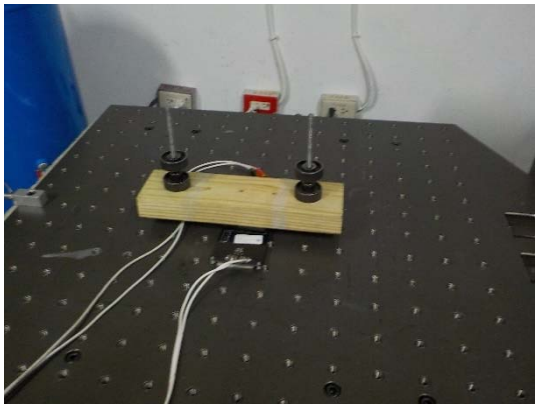
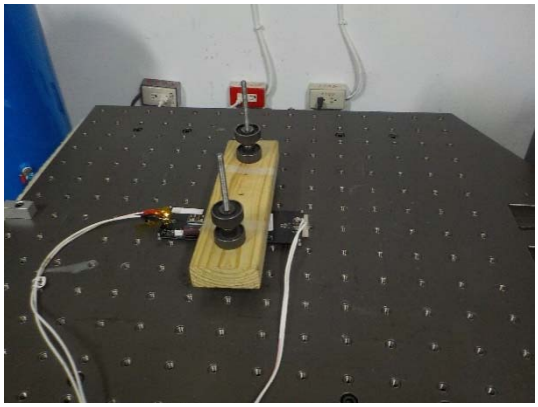
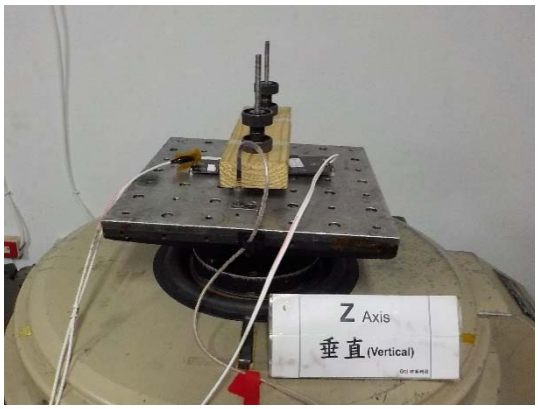
Test Procedure:

A. Check out samples.
B. Place the test samples on the vibration table in its normal operating Orientation and configuration.
C. Set test conditions and start to test.
D. Finish testing, check out samples and prepare final report.

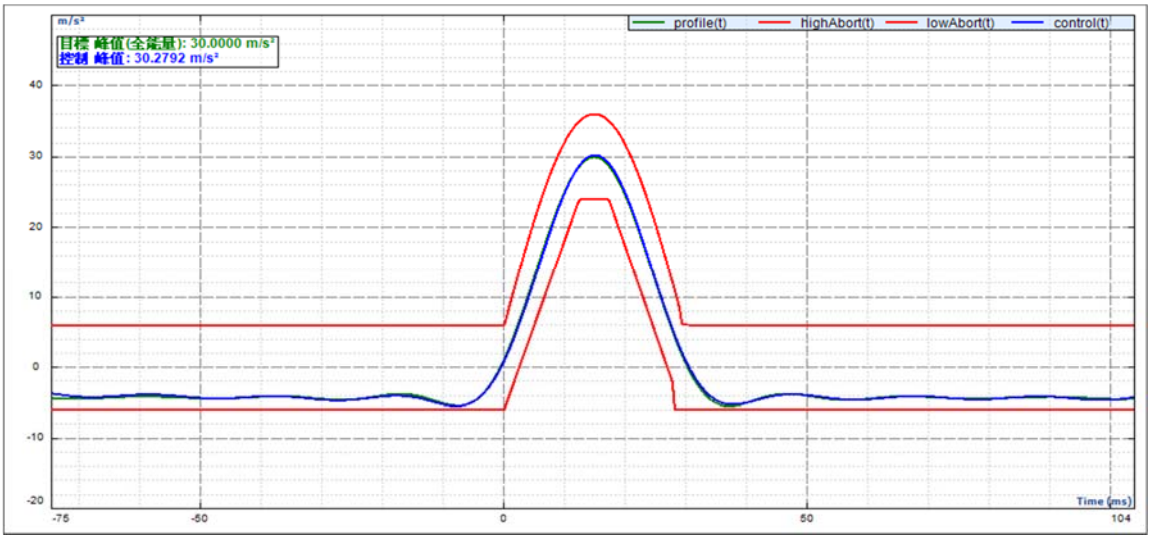
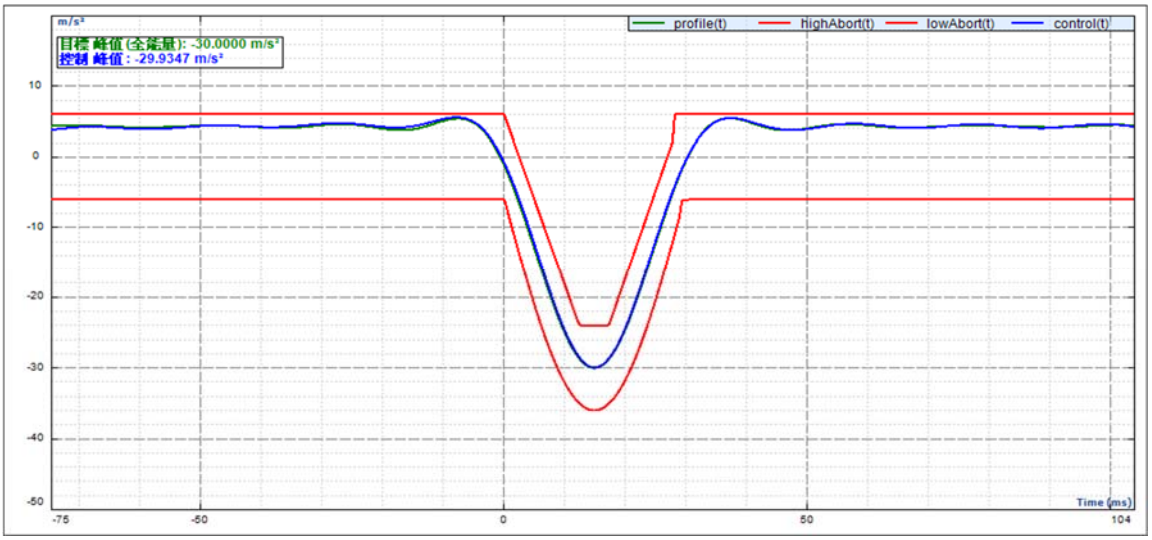
4.6.4 Test Result

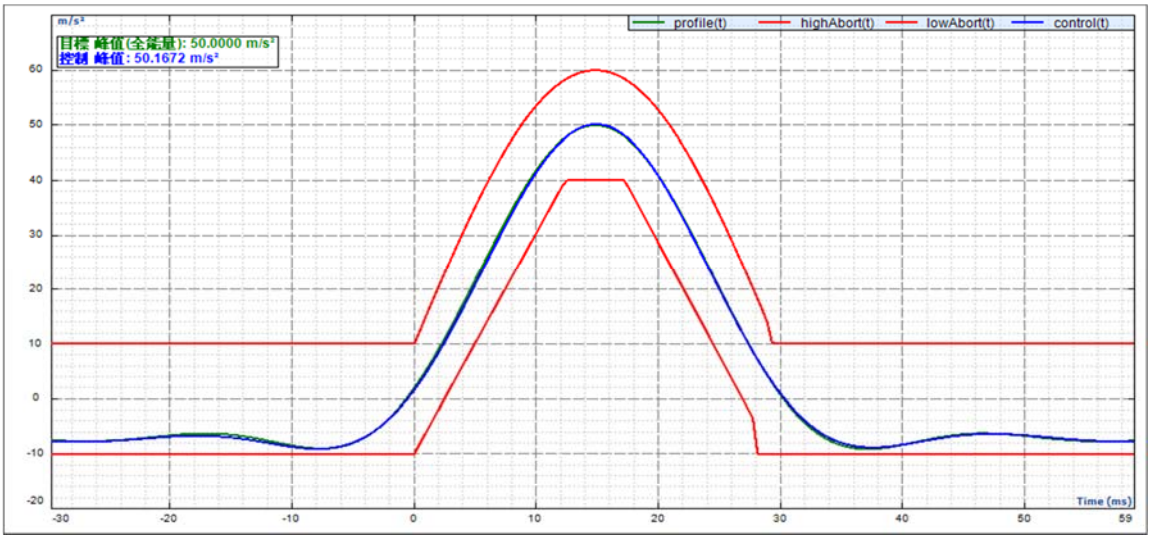
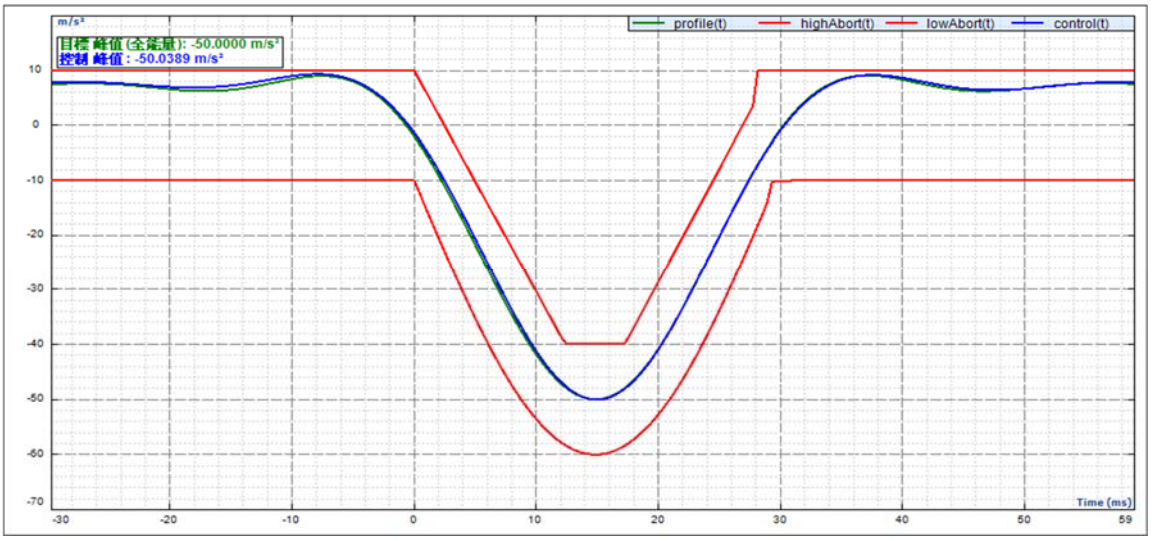
Inspection item	Result
EUT	Pass

4.6.5 Test Setup Photo

Transverse	
Longitudinal	
Vertical	

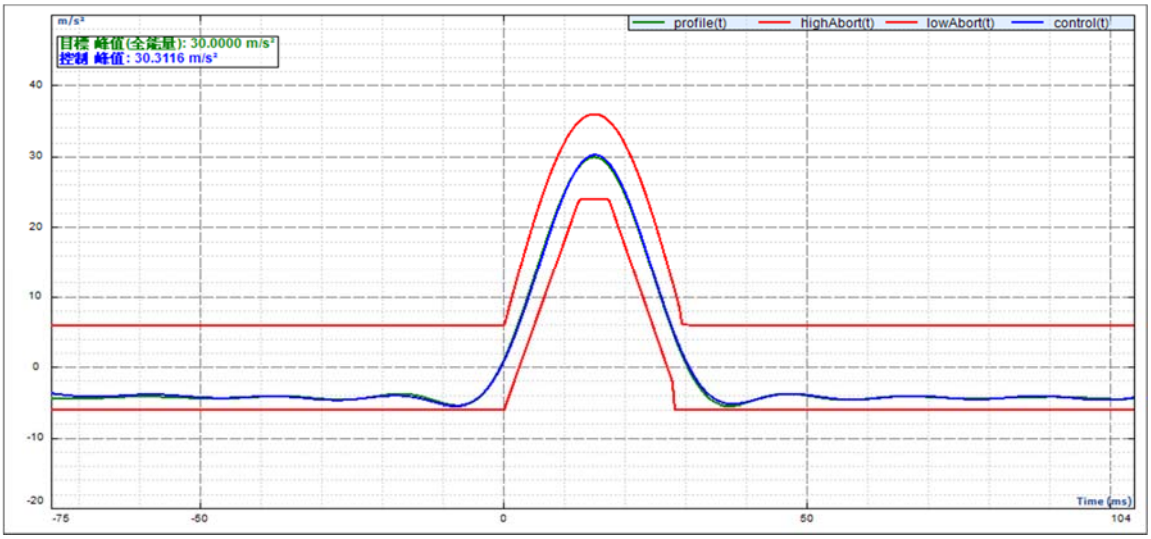
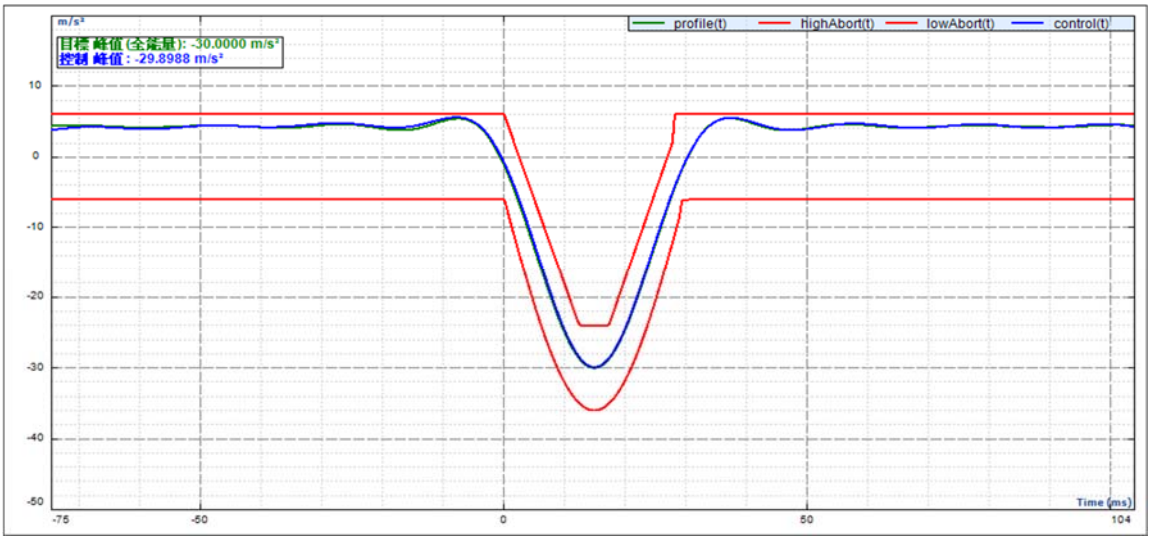
4.6.6 Test Profile:

+ X Axis

- X Axis


+ Y Axis

- Y Axis


m/s²
目標 峰值(全能量): 50.0000 m/s²
控制 峰值: 50.1672 m/s²
profile(t)
highAbort(t)
lowAbort(t)
control(t)
Time (ms)

m/s²
目標 峰值(全能量): -50.0000 m/s²
控制 峰值: -50.0389 m/s²
profile(t)
highAbort(t)
lowAbort(t)
control(t)
Time (ms)

+ Z Axis

- Z Axis


m/s²
目標 峰值(全能量): 30.0000 m/s²
控制 峰值: 30.3116 m/s²
profile(t)
highAbort(t)
lowAbort(t)
control(t)
40
30
20
10
0
-10
-20
-75
-50
0
50
104
Time (ms)

m/s²
目標 峰值(全能量): -30.0000 m/s²
控制 峰值: -29.8988 m/s²
profile(t)
highAbort(t)
lowAbort(t)
control(t)
10
0
-10
-20
-30
-40
-50
-75
-50
0
50
104
Time (ms)

5. Appendix

5.1 Appendix A: Test Equipment

5.1.1 Test Equipment List

Safety Equipment Calibration List

Equipment	Model	Manufacturer	Serial No.	Equipment Range	Cal. Date	Due Date
Electrical safety analyzer	SE 7452	Extech Electronics .	1713353	AC 5kV/100mA, DC 6kV/10mA Insulation: 10M ohm ~ 10G ohm	06/02/2021	06/02/2022
Temperature & Humidity Record	TH110-POSE	KIMO	1F130907473	Temperature10°C~35°C Humidity 20%~95%	04/08/2021	04/08/2022

Safety Equipment Calibration List

Equipment	Model	Manufacturer	Serial No.	Equipment Range	Cal. Date	Due Date
Electrical safety analyzer	SE 7452	Extech Electronics .	1713353	AC 5kV/100mA, DC 6kV/10mA Insulation: 10M ohm ~ 10G ohm	06/02/2021	06/02/2022
Chamber	THS-B4T-150	King San Technology	5290K	Temperature -40~150°C Humidity 10~95%	11/18/2020	11/18/2021
Temperature & Humidity Record	TH110-POSE	KIMO	1F130907473	Temperature10°C~35°C Humidity 20%~95%	04/08/2021	04/08/2022
Digital Timer - Alarm Clock	TM-5955	AVDr.AV	ISL-LT014	Timer (Full Range)	11/06/2020	11/06/2021

Location	Equipment Name	Brand	Model	S/N	Last Cal. Date	Next Cal. Date
Conduction 03	EMI Receiver 15	ROHDE & SCHWARZ	ESCI	101166	07/07/2021	07/07/2022
Conduction 03	Chamber05 -1 Cable	WOKEN	CFD 300-NL	Chamber05 -1 Cable	08/30/2021	08/30/2022
Conduction 03	LISN 19	R&S	ENV216	101425	11/11/2021	11/11/2022
Conduction 03	LISN 22	R&S	ENV216	101478	10/28/2021	10/28/2022
Conduction 03	LISN 24	SCHWARZBECK	NNLK 8121	8121-829	07/26/2021	07/26/2022
Conduction 03	ISN T4 09	Teseq GmbH	ISN T400A	49914	08/02/2021	08/02/2022
Conduction 03	ISN T8 09	Teseq GmbH	ISN T800	36190	09/30/2021	09/30/2022
Conduction 03	ISN T8 CAT6A_01	SCHWARZBECK	NTFM 8158	8158 0123	01/25/2022	01/25/2023
Conduction 03	CDN ISN ST08A_1	Teseq GmbH	CDN ISN ST08A	43352	10/07/2021	10/07/2022
Conduction 03	Capacitive Voltage Probe 01	SCHAFFNER	CVP 2200A	18711	02/23/2022	02/23/2023
Conduction 03	Current Probe	SCHAFFNER	SMZ 11	18030	02/23/2022	02/23/2023

Location Chamber02	Equipment Name	Brand	Model	S/N	Last Cal. Date	Next Cal. Date
Radiation	BILOG Antenna 19 (30MHz~1GHz)	SCHWARZBECK	VULB 9168+EMCI-N-6-05	643	05/10/2021	05/10/2022
Radiation	Preamplifier 28	EMCI	EMC9135	980296	08/18/2021	08/18/2022
Radiation	Coaxial Cable Chmb 02-10M-02	EMC	RG214U	Chmb 02-10M-02	10/13/2021	10/13/2022
Radiation	EMI Receiver 12	ROHDE & SCHWARZ	ESCI	100804	08/04/2021	08/04/2022

Location	Equipment Name	Brand	Model	S/N	Last Cal. Date	Next Cal. Date
EN61K-4-2	ESD Gun 12	EM TEST	Dito	P1650188689	05/05/2021	05/05/2022
EN61K-4-3	Broadband Log-Periodic Antenna 80Mz~1GHz	AR	ATL80M1G	0340509	N/A	N/A
EN61K-4-3	Horn Antenna RF-01	AR	ATS700M11G	0335864	N/A	N/A
EN61K-4-3	Amplifier 80Mz~1GHz 750W	AR	750W1000A	0344168	N/A	N/A
EN61K-4-3	Amplifier 800MHz~4.2GHz 50W	AR	50S1G4M1	312762	N/A	N/A
EN61K-4-3	Amplifier 4.0~8.0GHz 35W	AR	35S4G8AM1	0335752	N/A	N/A
EN61K-4-3	Broadband Coupler 80MHz~1GHz 63dB	AR	DC6280AM1	0343831	N/A	N/A
EN61K-4-3	Coaxial Cable	INSULATED	NPS-4806-2360-NP3	108599.003.01.03	N/A	N/A
EN61K-4-3	Broadband Coupler 0.8G~4.26GHz	AR	DC7144A	0335226	N/A	N/A
EN61K-4-3	Broadband Coupler 4G~8GHz	AR	DC7350A	0335817	N/A	N/A
EN61K-4-3	Signal Generator 08	ROHDE&SCHWARZ	SMB100A	106541	05/12/2021	05/12/2022
EN61K-4-4 EN61K-4-5	Signal Generator 10	EMC Partner	IMU3000	1547	09/15/2020	09/15/2021
EN61K-4-6	CDN M2+M3 04	TESEQ	CDN M016	43257	09/01/2021	09/01/2022
EN61K-4-6	Coaxial Cable 4-6 02-1			4-6 02-1	N/A	N/A
EN61K-4-6	Conducted Immunity Test System 03	Frankonia	CIT-10-75	126B1151	01/15/2020	01/15/2021
EN61K-4-8	Magnetic Field Test Generator 02	PIC	PMF-1000	ANT150701	05/31/2021	05/31/2022
EN61K-4-17, 4-29	Multifunction AC/DC Power Source	EMTEST	Netwave 7-400	P1453146268	11/16/2020	05/16/2021

PS: N/A => The equipment does not need calibration.

**Software for Controlling Spectrum/Receiver and Calculating Test Data

Test Item	Filename	Version
EN 61000-4-2	N/A	2.0
EN 61000-4-3	i2	529b
EN 61000-4-4	TEM A3000	V4.6.1
EN 61000-4-5	TEM A3000	V4.6.1
EN 61000-4-6	FRANKONIA CD-LAB	V5.221
EN 61000-4-8	N/A	

Site	Filename	Version	Issue Date
Conduction/Radiation	EZ EMC	ISL-03A2	3/6/2013

5.2 Appendix B: Uncertainty of Measurement

The laboratory measurement uncertainty accordance with refers to CISPR 16-4-2. If Ulab is less than or equal to Ucispr in Table 1, then the test report may either state the value of Ulab or state that Ulab is less than Ucispr.
The coverage factor k = 2 yields approximately a 95 % level of confidence.

<Conduction 03>
AMN: ± 2.90dB

<Chamber 02 (10m)>
Horizontal
30MHz~200MHz: ±4.42dB
200MHz~1000MHz: ±3.83dB
Vertical
30MHz~200MHz: ±4.57dB
200MHz~1000MHz: ±3.97dB

<Immunity 02>

Test item	Uncertainty	Test item	Uncertainty
EN 61000-4-2 (ESD)		EN 61000-4-6 (CS)	
Rise time tr	≦ 9.81%	CDN	± 1.74dB
Peak current Ip	≦ 5.54%	EM Clamp	± 3.36dB
current at 30 ns	≦ 5.55%	EN 61000-4-8 (Magnetic)	± 6.53%
current at 60 ns	≦ 5.55%		
EN 61000-4-3 (RS)	± 1.89dB		
EN 61000-4-4 (EFT)			
voltage rise time (tr)	± 5.1%		
peak voltage value (VP)	± 6.39%		
voltage pulse width (tw)	± 5.0%		
EN 61000-4-5 (Surge)			
open-circuit voltage front time	±13.5%		
open-circuit voltage peak value	±6.6%		
open-circuit voltage duration (Td)	53.33μs		

5.3 Appendix C: Photographs of EUT

Please refer to the File of **ISL-21LE654P-R1-MA**

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